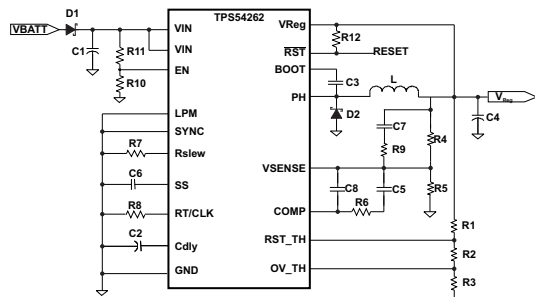


TPS54262-EP Iq 较低并配有电压监测器的 2A、60V 降压 DC-DC 转换器

1 特性

- 异步开关模式稳压器
- 适用于汽车电子 应用
- 3.6V 至 48V 运行范围，可耐受高达 60V 的瞬态电压
- 2A 最大负载电流
- 50 μ A 静态电流（典型值）
- 200kHz 至 2.2MHz 开关频率
- 0.8V \pm 1.5% 电压基准
- 耐高压的使能输入
- 启用周期上的软启动
- 内部电源开关上的转换率控制
- 低功耗模式，适用于轻载条件
- 可通过编程设定的上电复位延迟
- 误差放大器外部补偿
- 针对快速负瞬态变化的复位功能滤波时间
- 可编程过压、欠压输出监测计
- 热感应和关断
- 开关电流限制保护
- 场效应晶体管 (FET) 的短路和过流保护
- 结温范围：-55 $^{\circ}$ C 至 150 $^{\circ}$ C
- 20 引脚散热薄型小外形尺寸 (HTSSOP) PowerPAD™ 的 8 引脚小外形尺寸 (SO) 封装
- 支持国防、航天和医疗 应用：
 - 可控基线
 - 一个组装/测试场所
 - 一个制造场所
 - 在扩展温度范围（-55 $^{\circ}$ C 至 125 $^{\circ}$ C）内可用
 - 延长的产品生命周期
 - 延长产品的变更通知
 - 产品可追溯性

简化电路原理图



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2 应用范围

- 汽车远程信息处理和紧急呼叫
- 汽车信息娱乐系统和仪表盘
 - 音响主机
 - 导航
 - 显示屏

3 说明

TPS54262-EP 器件是一款 60V、2A 降压开关模式电源，支持低功耗模式并配有集成 N 沟道金属氧化物半导体 (NMOS) 开关 FET 的可编程电压监控器。集成输入电压线路前馈拓扑结构改进了电压模式降压稳压器的线路瞬态稳压性能。稳压器具有逐周期电流限值。此外，该器件还具备在轻载条件下以低功耗模式运行的特性，可将电源电流降至 50 μ A（典型值）。通过将 EN 引脚下拉为低电平，电源关断电流可降至 1 μ A（典型值）。

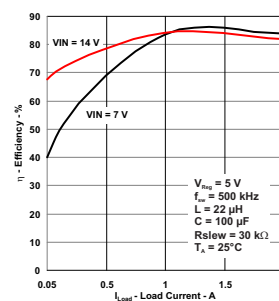
开漏复位信号指示标称输出降至通过外部电阻分压器网络设置的复位阈值以下。输出电压启动斜坡由软启动电容控制。内部欠压关断在输入电源电压斜降至 2.6V 时激活。该器件具有短路保护电路，能够在过载条件下为器件提供保护，此外还具备热关断保护功能。

器件信息⁽¹⁾

器件型号	封装	封装尺寸（标称值）
TPS54262-EP	HTSSOP (20)	6.50mm x 4.40mm

(1) 要了解所有可用封装，请见数据表末尾的可订购产品附录。

转换器典型效率



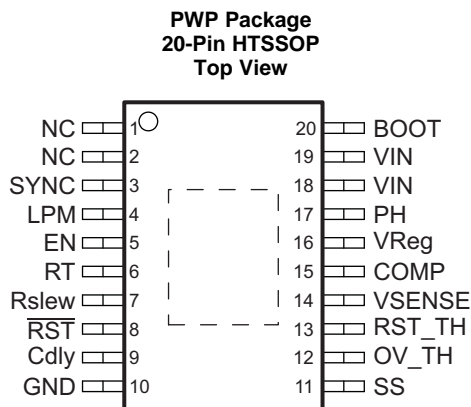
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4 修订历史记录

日期	修订版本	注释
2016 年 12 月	*	最初发布。

5 Pin Configuration and Functions



Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
NC	1	NC	Connect to ground.
NC	2	NC	Connect to ground.
SYNC	3	I	External synchronization clock input to override the internal oscillator clock. An internal pulldown resistor of 62 kΩ (typical) is connected to ground. Connect this pin to GND if not used.
LPM	4	I	Low-power mode control using digital input signal. An internal pulldown resistor of 62 kΩ (typical) is connected to ground.
EN	5	I	Enable pin, internally pulled up. Must be externally pulled up or down to enable or disable the device.
RT	6	O	External resistor to ground to program the internal oscillator frequency.
Rslew	7	O	External resistor to ground to control the slew rate of internal switching FET.
$\overline{\text{RST}}$	8	O	Active low, open-drain reset output connected to external bias voltage through a resistor, asserted high after the device starts regulating.
Cdly	9	O	External capacitor to ground to program power on reset delay.
GND	10	O	Ground pin, must be electrically connected to the exposed pad on the PCB for proper thermal performance.
SS	11	O	External capacitor to ground to program soft-start time.
OV_TH	12	I	Sense input for overvoltage detection on regulated output, an external resistor network is connected between VReg and ground to program the overvoltage threshold.
RST_TH	13	I	Sense input for undervoltage detection on regulated output, an external resistor network is connected between VReg and ground to program the reset and undervoltage threshold.
VSENSE	14	I	Inverting node of error amplifier for voltage mode control.
COMP	15	O	Error amplifier output to connect external compensation components.
VReg	16	I	Internal low-side FET to load output during start-up or limit overshoot.
PH	17	O	Source of the internal switching FET.
VIN	18	I	Unregulated input voltage. Pin 18 and pin 19 must be connected externally.
VIN	19	I	Unregulated input voltage. Pin 18 and pin 19 must be connected externally.
BOOT	20	O	External bootstrap capacitor to PH to drive the gate of the internal switching FET.

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT	
Input voltage	EN	-0.3	60	V	
	VIN	-0.3	60		
	VReg	-0.3	20		
	LPM	-0.3	5.5		
	OV_TH	-0.3	5.5		
	RST_TH	-0.3	5.5		
	SYNC	-0.3	5.5		
	VSENSE	-0.3	5.5		
Output voltage	BOOT	-0.3	65	V	
	PH	DC voltage	-0.3		60
		DC voltage, T _J = -55°C	-0.85		
		DC voltage, T _J = 125°C	-0.5		
		30-ns transient pulse	-2		
		200-ns transient pulse	-1		
	RT	-0.3	5.5		
	$\overline{\text{RST}}$	-0.3	5.5		
	Cdly	-0.3	8		
	SS	-0.3	8		
COMP	-0.3	7			
Operating virtual junction temperature, T _J		-55	150	°C	
Storage temperature, T _{stg}		-55	165	°C	

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

		VALUE	UNIT
V _(ESD) Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±750	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V _I	Unregulated buck supply input voltage (VIN, EN)	3.6		48	V
V _{Reg}	Regulated output voltage	In continuous conduction mode (CCM)		18	V
		Power up in low-power mode (LPM) or discontinuous conduction mode (DCM)		5.5	V
Bootstrap capacitor (BOOT)		3.6		56	V
Switched outputs (PH)		3.6		48	V
Logic levels ($\overline{\text{RST}}$, VSENSE, OV_TH, RST_TH, Rslew, SYNC, RT)		0		5.25	V
Logic levels (SS, Cdly, COMP)		0		6.5	V
T _A	Operating ambient temperature	-55		125	°C

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		TPS54262-EP	
		PWP (HTSSOP)	
		20 PINS	
			UNIT
R _{θJA}	Junction-to-ambient thermal resistance	37.1	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	20.8	°C/W
R _{θJB}	Junction-to-board thermal resistance	8.7	°C/W
ψ _{JT}	Junction-to-top characterization parameter	0.3	°C/W
ψ _{JB}	Junction-to-board characterization parameter	8.7	°C/W
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	1.2	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 DC Electrical Characteristics

V_{IN} = 7 V to 48 V, EN = VIN, T_J = –55°C to 150°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS		TEST ⁽¹⁾	MIN	TYP	MAX	UNIT
INPUT POWER SUPPLY								
V _{IN}	Supply voltage on V _{IN}	Normal mode: after initial start-up		Info	3.6		48	V
		Low-power mode	Falling threshold (LPM disabled)			8		
			Rising threshold (LPM activated)			8.5		
			High voltage threshold (LPM disabled)		29	31	34	
I _{q-Normal}	Quiescent current, normal mode	Open loop test – maximum duty cycle V _{IN} = 7 V to 48 V		PT		5	10	mA
I _{q-LPM}	Quiescent current, low-power mode	I _{Load} < 1 mA, V _{IN} = 12 V	T _A = 25°C	PT		50	70	μA
			–55 < T _J < 150°C			75		
		I _{Load} < 1 mA, V _{IN} = 24 V	T _A = 25°C			75		
			–55 < T _J < 150°C			75		
I _{SD}	Shutdown current	EN = 0 V, device is off	T _A = 25°C, V _{IN} = 12 V	PT		1	4	μA
TRANSITION TIMES (LOW POWER – NORMAL MODES)								
t _{d1}	Transition delay, normal mode to low-power mode	V _{IN} = 12 V, V _{Reg} = 5 V, I _{Load} = 1 A to 1 mA		CT		100		μs
t _{d2}	Transition delay, low-power mode to normal mode	V _{IN} = 12 V, V _{Reg} = 5 V, I _{Load} = 1 mA to 1 A		CT		5		μs
SWITCH MODE SUPPLY; V_{Reg}								
V _{Reg}	Regulator output	V _{SENSE} = 0.8 V _{ref}		Info	0.9		18	V
V _{SENSE}	Feedback voltage	V _{Reg} = 0.9 V to 18 V (open loop)		CT	0.788	0.8	0.812	V
R _{DS(ON)}	Internal switch resistance	Measured across V _{IN} and PH, I _{Load} = 500 mA		PT			500	mΩ
I _{CL}	Switch current limit, cycle by cycle	V _{IN} = 12 V		Info	2.5	3.2	4.1	A
t _{ON-Min}	Duty cycle pulse width	Bench CHAR only		Info	50	100	150	ns
t _{OFF-Min}		Bench CHAR only		Info	100	200	250	ns
f _{sw}	Switching frequency	Set using external resistor on RT pin		PT	0.2		2.2	MHz
f _{sw}	Internal oscillator frequency tolerance			PT	–10%		10%	
I _{Sink}	Start-up condition	OV_TH = 0 V, V _{Reg} = 10 V		Info			1	mA
I _{Limit}	Prevent overshoot	0 V < OV_TH < 0.8 V, V _{Reg} = 10 V		Info			80	mA

(1) PT: Production tested
CT: Characterization tested only, not production tested
Info: User information only, not production tested

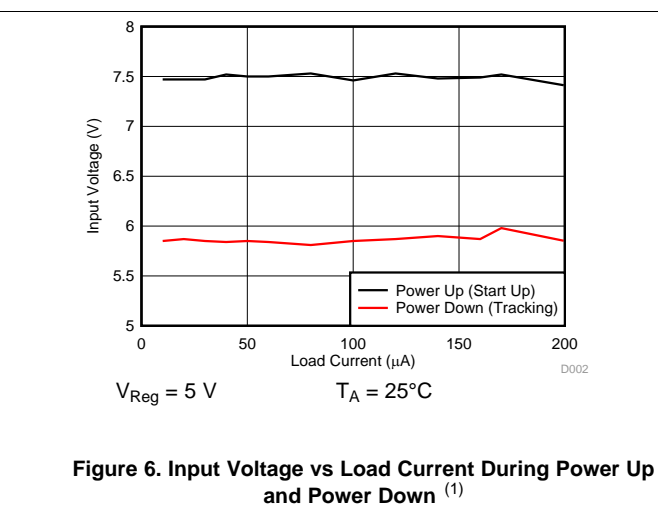
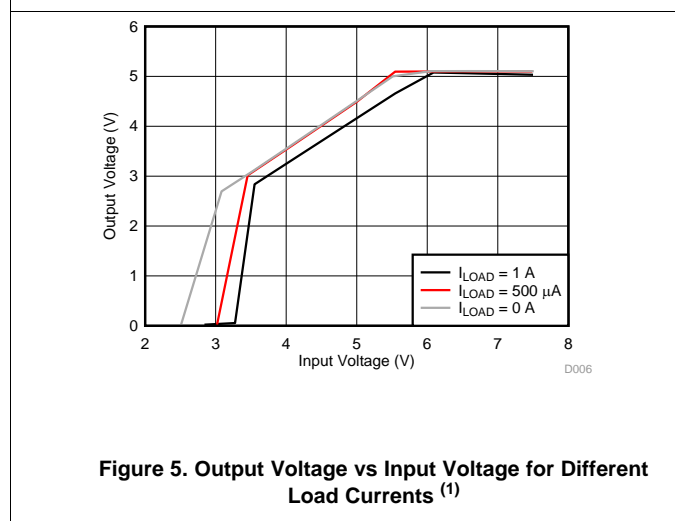
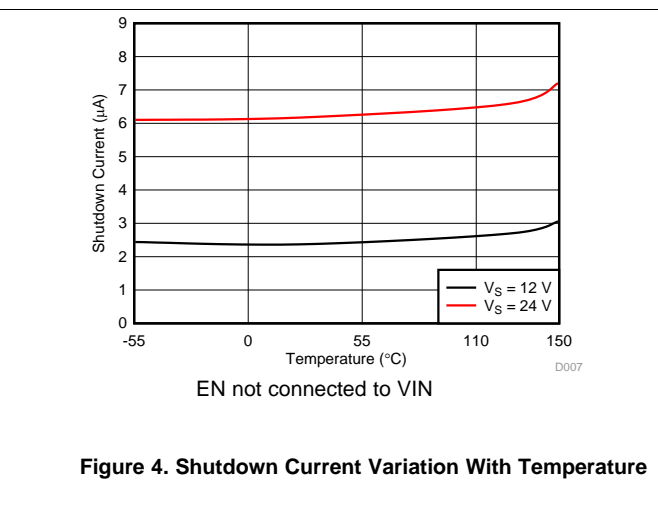
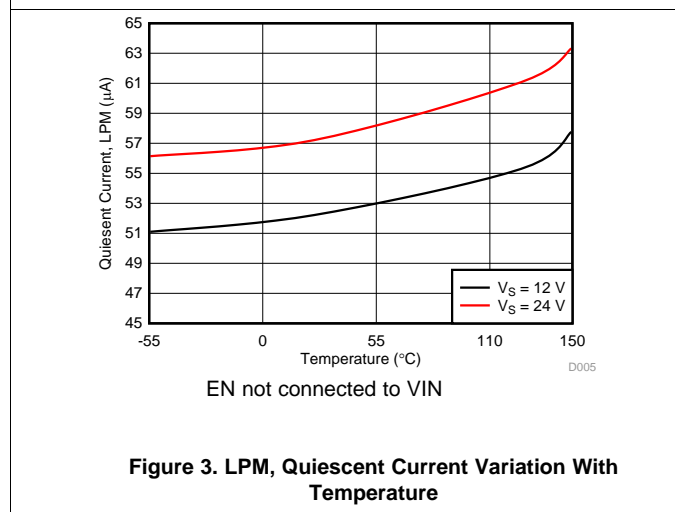
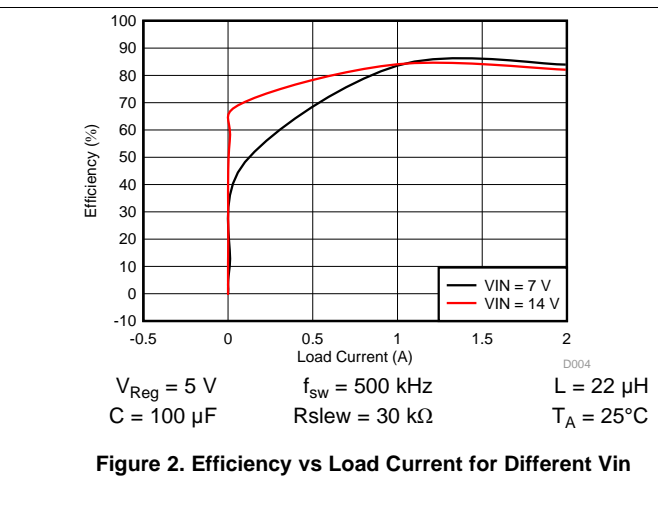
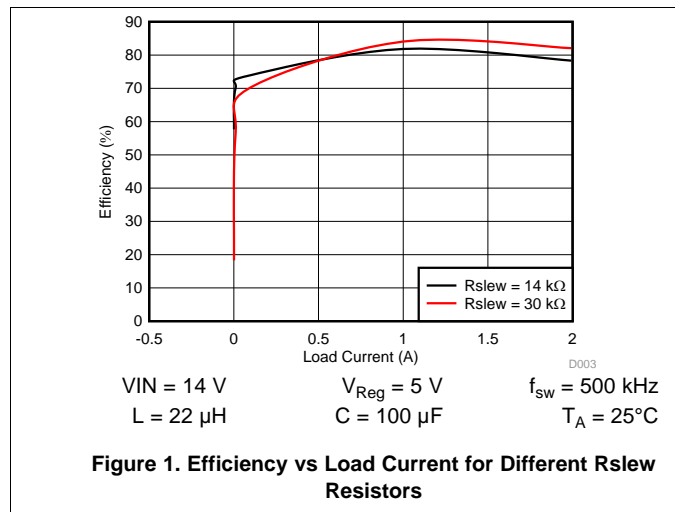
DC Electrical Characteristics (continued)

 VIN = 7 V to 48 V, EN = VIN, T_J = –55°C to 150°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS	TEST ⁽¹⁾	MIN	TYP	MAX	UNIT
ENABLE (EN)							
V _{IL}	Low input threshold voltage		PT			0.7	V
V _{IH}	High input threshold voltage		PT	1.7			V
I _{lkg}	Leakage current into EN terminal	EN = 60 V	PT		100	135	μA
		EN = 12 V			8	15	
RESET DELAY (Cdly)							
I _O	External capacitor charge current	EN = high	PT	1.4	2	3	μA
V _{Threshold}	Switching threshold voltage	Output voltage in regulation	PT		2		V
LOW-POWER MODE (LPM)							
V _{IL}	Low input threshold voltage	VIN = 12 V	PT			0.7	V
V _{IH}	High input threshold voltage	VIN = 12 V	PT	1.7			V
I _{lkg}	Leakage current into LPM terminal	LPM = 5 V	PT		65	95	μA
RESET OUTPUT (RST)							
t _{rdly}	POR delay timer	Based on Cdly capacitor	PT	3.2		7	ms/nF
V _{Reg_RST}	Reset threshold voltage for V _{Reg}	Check RST output	PT	0.768		0.832	V
t _{hRSTdly}	Filter time	Delay before RST is asserted low	PT	10	20	35	μs
SOFT START (SS)							
I _{SS}	Soft-start source current		PT	40	50	60	μA
SYNCHRONIZATION (SYNC)							
V _{IL}	Low input threshold voltage		PT			0.7	V
V _{IH}	High input threshold voltage		PT	1.7			V
I _{lkg}	Leakage current	SYNC = 5 V	PT		65	95	μA
SYNC (f _{ext})	External input clock frequency	VIN = 12 V, V _{Reg} = 5 V, 180 kHz < f _{sw} < f _{ext} < 2 × f _{sw} < 2.2 MHz	CT	180		2200	kHz
SYNC _{trans}	External clock to internal clock	No external clock, VIN = 12 V, V _{Reg} = 5 V	Info		32		μs
SYNC _{trans}	Internal clock to external clock	External clock = 1 MHz, VIN = 12 V, V _{Reg} = 5 V	Info		2.5		μs
SYNC _{CLK}	Minimum duty cycle		CT	30%			
SYNC _{CLK}	Maximum duty cycle		CT			70%	
Rslew							
I _{Rslew}	Rslew = 50 kΩ		CT		20		μA
I _{Rslew}	Rslew = 10 kΩ		CT		100		μA
OVERVOLTAGE SUPERVISORS (OV_TH)							
V _{Reg_OV}	Threshold voltage for V _{Reg} during overvoltage	Internal switch is turned off	PT	0.768		0.832	V
	V _{Reg} = 5 V	Internal pulldown on V _{Reg} , OV_TH = 1 V				70 ⁽²⁾	
THERMAL SHUTDOWN							
T _{SD}	Thermal shutdown junction temperature		CT		175		°C
T _{HYS}	Hysteresis		CT		30		°C

 (2) This is the current flowing into the V_{Reg} pin when voltage at OV_TH pin is 1 V.

6.6 Typical Characteristics



(1) **Figure 5** shows the dropout operation during low input conditions.
Figure 6 shows the following plots:
 (a) Power Up (Start Up): Input voltage required to achieve the 5-V regulation during power up over the range of load currents
 (b) Power Down (Tracking): Input voltage at which the output voltage drops approximately by 0.7 V from the programmed 5-V regulated voltage

Typical Characteristics (continued)

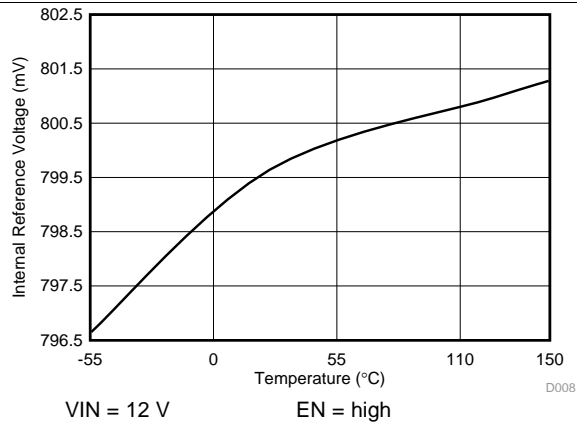


Figure 7. Internal Reference Voltage

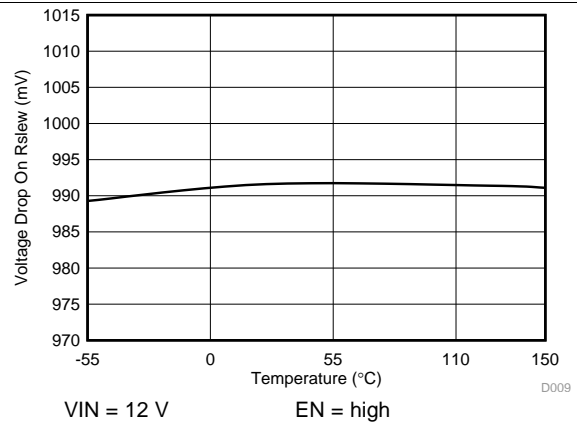


Figure 8. Voltage Drop ON Rslw for Current Reference (Slew Rate / Rslw)

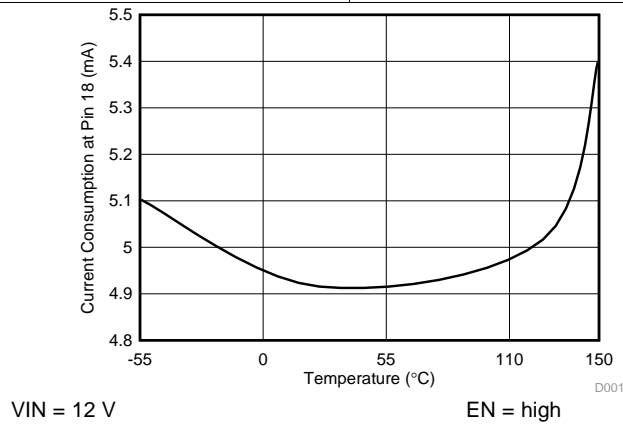


Figure 9. Current Consumption With Temperature

7 Detailed Description

7.1 Overview

The TPS54262-EP device is a 60-V, 2-A DC-DC step down (buck) converter using voltage-control mode scheme. The device features a supervisory function for power-on-reset during system power on. Once the output voltage has exceeded the threshold set by RST_TH pin, a delay of 1 ms/nF (based on capacitor value on Cdly terminal) is invoked before the $\overline{\text{RST}}$ line is released high. Conversely on power down, once the output voltage falls below the same set threshold, the $\overline{\text{RST}}$ line is pulled low only after a deglitch filter of approximately 20 μs (typical) expires. This is implemented to prevent reset from being triggered due to fast transient line noise on the regulated output supply.

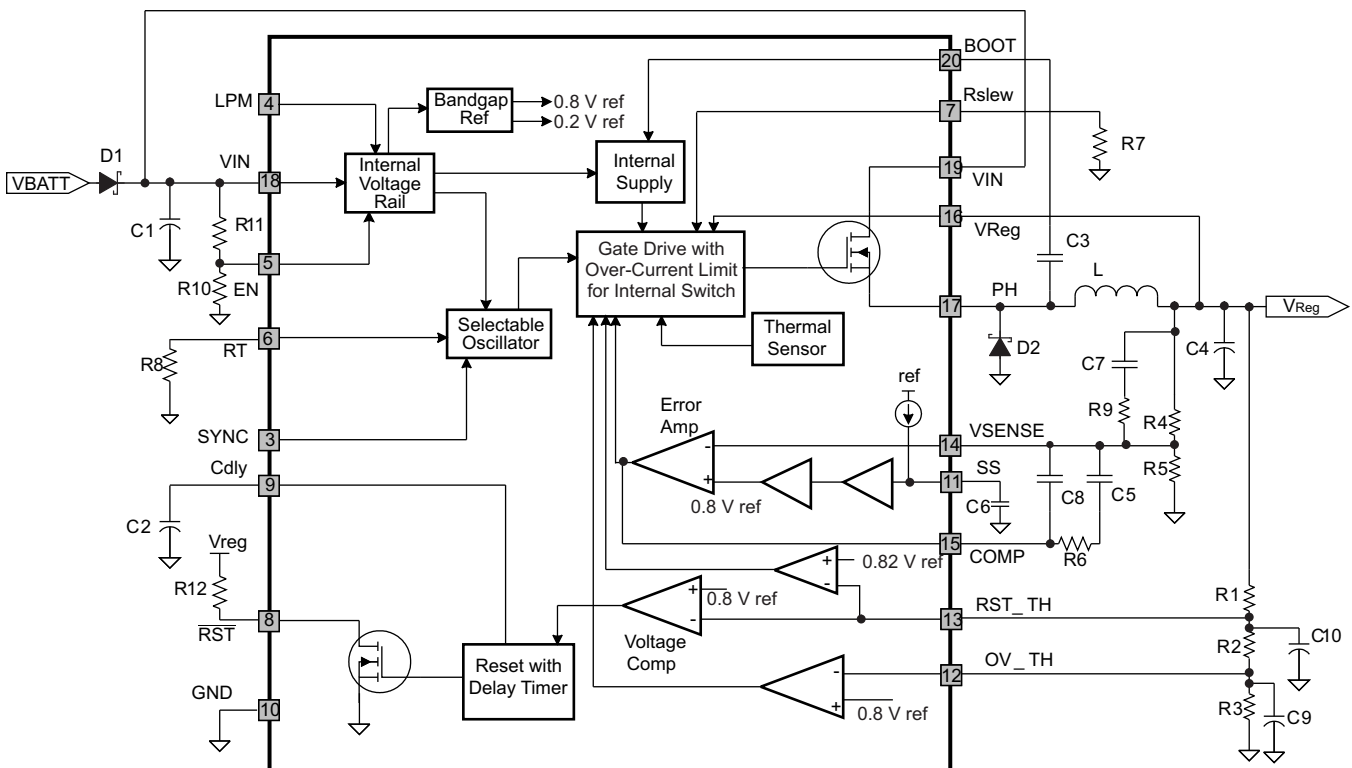
An overvoltage monitor function is used to limit regulated output voltage to the threshold set by OV_TH pin. Both the RST_TH and OV_TH monitoring voltages are set to be a prescale of the output voltage, and thresholds based on the internal bias voltages of the voltage comparators (0.8-V typical).

Detection of undervoltage on the regulated output is based on the RST_TH setting and will invoke $\overline{\text{RST}}$ line to be asserted low. Detection of overvoltage on the output is based on the OV_TH setting and will not invoke the $\overline{\text{RST}}$ line to be asserted low. However, the internal switch is commanded to turn OFF.

In systems where power consumption is critical, low-power mode (LPM) is implemented to reduce the non-switching quiescent current during light-load conditions. After the device has been operating in discontinuous conduction mode (DCM) for at least 100 μs (typical), depending upon the load current, it may enter in pulse skip mode (PSM). The operation of when the device enters DCM is dependent on the selection of the external components.

If thermal shutdown is invoked due to excessive power dissipation, the internal switch is disabled and the regulated output voltage starts to decrease. Depending on the load current, the regulated output voltage could decay and the RST_TH threshold may assert the $\overline{\text{RST}}$ output low.

7.2 Functional Block Diagram



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7.3 Feature Description

The TPS54262-EP device is a DC-DC converter using a voltage-control mode scheme with an input voltage feed-forward technique. The device can be programmed for a range of output voltages with a wide input voltage range. The following sections provide details regarding setting up the device, detailed functionality, and the modes of operation.

7.3.1 Unregulated Input Voltage

The input voltage is supplied through VIN pins (pin 18 and 19) which must be externally protected against voltage levels greater than 60 V and reverse input polarity. An external diode is connected to protect these pins from reverse input polarity. The input current drawn from this pin is pulsed, with fast rise and fall times. Therefore, this input line requires a filter capacitor to minimize noise. Additionally, for EMI considerations, an input filter inductor may also be required.

NOTE

For design considerations, V_{IN}/V_{Reg} ratios should always be set such that the minimum required duty cycle pulse (t_{ON-Min}) is greater than 150 ns. The minimum off time ($t_{OFF-Min}$) is 250 ns for all conditions.

7.3.2 Regulated Output Voltage

The regulated output voltage (V_{Reg}) is fed back to the device through VReg pin (pin 16). Typically, an output capacitor of value within range of 10 μ F to 400 μ F is connected at this pin. TI also recommends using a filter capacitor with low ESR characteristics to minimize ripple in regulated output voltage. The VReg pin is also internally connected to a load of approximately 100 Ω , which is turned ON in the following conditions:

- During start-up condition, when the device is powered up with no-load, or whenever EN is toggled, the internal load connected to VReg pin is turned ON to charge the bootstrap capacitor to provide gate drive voltage to the switching transistor.
- During normal operating conditions, when the regulated output voltage (V_{Reg}) exceeds the overvoltage threshold (VReg_OV, preset by external resistors R1, R2, and R3), the internal load is turned ON, and this pin is pulled down to bring the regulated output voltage down.
- When V_{IN} is less than typical V_{IN} falling threshold level while LPM is disabled. From device specifications, V_{IN} typical falling threshold (LPM disabled) = 8 V (see [DC Electrical Characteristics](#)).
- When \overline{RST} is low.

7.3.3 Regulation and Feedback Voltage

The regulated output voltage (V_{Reg}) can be programmed by connecting external resistor network at VSENSE pin (pin 14). The output voltage is selectable from 0.9 V to 18 V according to the following relationship:

$$V_{Reg} = V_{ref} \left(1 + \frac{R4}{R5} \right)$$

where

- R4, R5 = feedback resistors (see [Functional Block Diagram](#))
- $V_{ref} = 0.8$ V (typical) (1)

The overall tolerance of the regulated output voltage is given by [Equation 2](#).

$$tol_{V_{Reg}} = tol_{V_{ref}} + \frac{R4}{R4 + R5} \times (tol_{R4} + tol_{R5})$$

where

- $tol_{V_{ref}}$ = tolerance of internal reference voltage ($tol_{V_{ref}} = \pm 1.5\%$)
- tol_{R4}, tol_{R5} = tolerance of feedback resistors R4, R5 (2)

For a tighter tolerance on V_{Reg} , lower-value feedback resistors can be selected. However, for proper operation in low-power mode (see [Figure 17](#)), TI recommends keeping $R4 + R5$ around 250 k Ω (typical).

The output tracking depends upon the loading conditions and is explained in [Table 1](#) and is shown in [Figure 6](#).

Feature Description (continued)

Table 1. Load Conditions

LOAD CONDITION	OUTPUT TRACKING
Nominal load in CCM	V_{Reg} tracks VIN approximately as: $V_{Reg} = 95\% (VIN - I_{Load} \times 0.5)$
No load/light load in LPM	To enable the tracking feature, following conditions should be met: 1) $f_{SW} < 600$ kHz 2) $V_{Reg} < 8$ V, typical (related to VIN falling threshold when LPM is disabled)

7.3.4 Enable and Shutdown

The EN pin (pin 5) provides electrical ON/OFF control of the regulator. Once the EN pin voltage exceeds the upper threshold voltage (V_{IH}), the regulator starts operating and the internal soft start begins to ramp. If the EN pin voltage is pulled below the lower threshold voltage (V_{IL}), the regulator stops switching and the internal soft start resets. Connecting this pin to ground or to any voltage less than V_{IL} disables the regulator and causes the device to shut down. This pin must have an external pullup or pulldown to change the state of the device.

7.3.5 Soft Start

An external soft-start capacitor is connected to SS pin (pin 11) to set the minimum time to reach the desired regulated output voltage (V_{Reg}) during power-up cycle. This prevents the output voltage from overshooting when the device is powered up. This is also useful when the load requires a controlled voltage slew rate, and also helps to limit the current drawn from the input voltage supply line.

For proper operation, the following conditions must be satisfied during power up and after a short circuit event:

- $VIN - V_{Reg} > 2.5$ V
- Load current < 1 A, until \overline{RST} goes high

The power-up current limit (30% of the typical current limit value) is released after the feedback voltage (at VSENSE pin) is high enough such that \overline{RST} is asserted high. The recommended value of soft-start capacitor is 100 nF (typical) for start-up load current of 1 A (maximum).

7.3.6 Oscillator Frequency

The oscillator frequency can be set by connecting an external resistor (R8 in [Functional Block Diagram](#)) to RT pin (pin 6). [Figure 10](#) shows the relation between the resistor value (RT) and switching frequency (f_{sw}). The switching frequency can be set in the range 200 kHz to 2200 kHz. In addition, the switching frequency can be imposed externally by a clock signal (f_{ext}) at the SYNC pin.

7.3.6.1 Selecting the Switching Frequency

A power supply switching at a higher switching frequency allows use of lower value inductor and smaller output capacitor compared to a power supply that switches at a lower frequency. Typically, the user will want to choose the highest switching frequency possible because this will produce the smallest solution size. The switching frequency that can be selected is limited by the following factors:

- The input voltage
- The minimum target regulated voltage
- Minimum on-time of the internal switching transistor
- Frequency shift limitation

Selecting lower switching frequency results in using an inductor and capacitor of a larger value, where as selecting higher switching frequency results in higher switching and gate drive power losses. Therefore, a tradeoff must be made between physical size of the power supply and the power dissipation at the system/application level.

The minimum and maximum duty cycles can be expressed in terms of input and output voltage as shown in Equation 3.

$$D_{Min} = \frac{V_{Reg - Min}}{VIN_{Max}} \quad \text{and} \quad D_{Max} = \frac{V_{Reg - Min}}{VIN_{Min}}$$

where

- D_{Min} = minimum duty cycle
 - D_{Max} = maximum duty cycle
 - VIN_{Min} = minimum input voltage
 - VIN_{Max} = maximum input voltage
 - $V_{Reg - Min}$ = minimum regulated output voltage
 - $V_{Reg - Max}$ = maximum regulated output voltage
- (3)

Maximum switching frequency can be calculated using Equation 4.

$$f_{sw - Max} = \frac{V_{Reg - Min} / VIN_{Max}}{t_{ON - Min}}$$

where

- $f_{sw - Max}$ = maximum switching frequency
 - $t_{ON - Min}$ = minimum on-time of the NMOS switching transistor
- (4)

Knowing the switching frequency, the value of resistor to be connected at RT pin can be calculated using the graph shown in Figure 10. Consider the oscillator tolerance ($\pm 10\%$) while selecting the external RT resistor. For example if $f_{sw} = 2.2$ MHz is required, select the RT resistor which corresponds to $f_{sw} = 2$ MHz in Figure 10 to allow +10% oscillator tolerance.

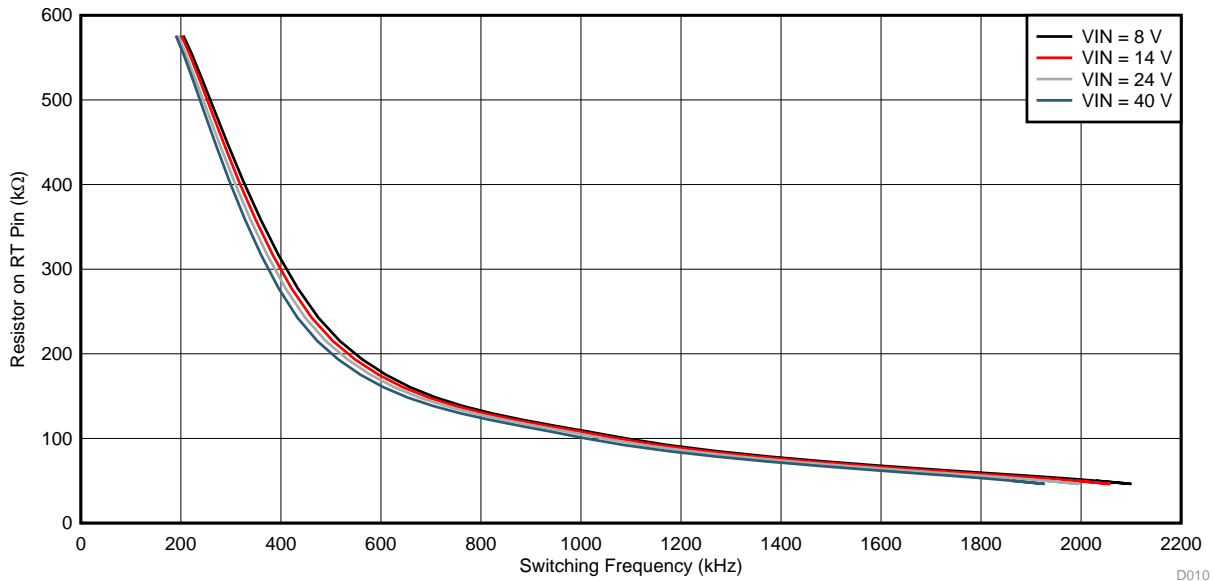


Figure 10. Switching Frequency vs Resistor Value

7.3.6.2 Synchronization With External Clock

An external clock signal can be supplied to the device through SYNC pin (pin 3) to synchronize the internal oscillator frequency with an external clock frequency. The synchronization input overrides the internal fixed oscillator signal. The synchronization signal must be valid for approximately two clock cycles before the transition is made for synchronization with the external frequency input. If the external clock input does not transition low or high for 32 μ s (typical), the system defaults to the internal clock set by the resistor connected to the RT pin. The SYNC input can have a frequency according to Equation 5.

$$180 \text{ kHz} < f_{\text{sw}} < f_{\text{ext}} < 2 \times f_{\text{sw}} < 2.2 \text{ MHz}$$

where

- f_{sw} = oscillator frequency determined by resistor connected to the RT pin
- f_{ext} = frequency of the external clock fed through SYNC pin

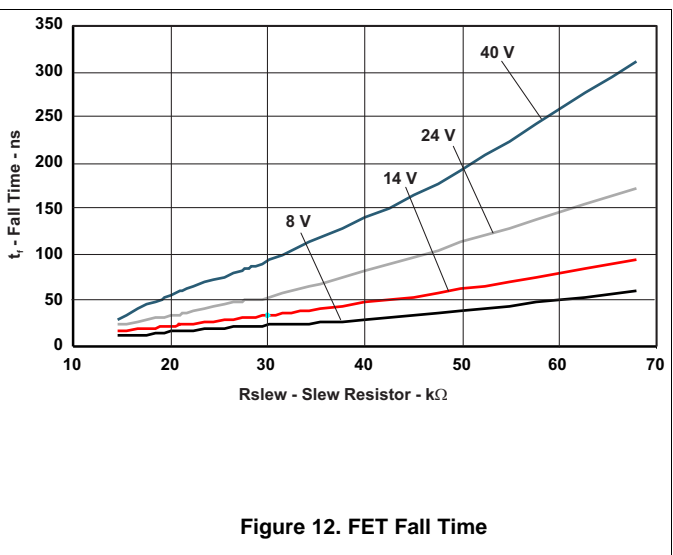
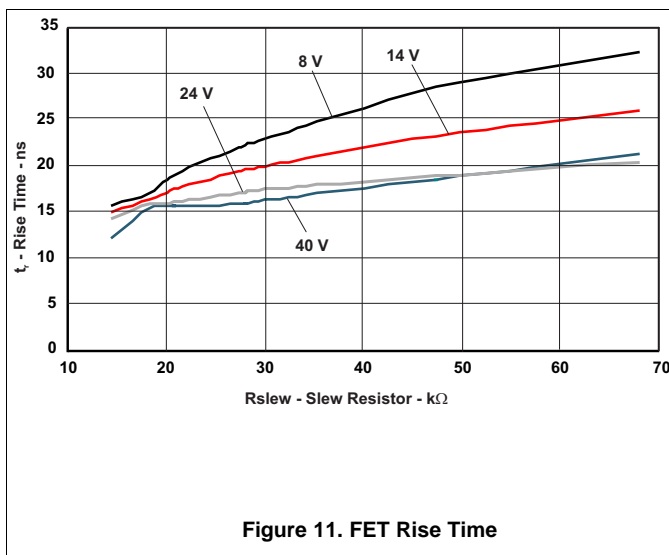
For example, if the resistor connected at RT pin is selected such that the switching frequency (f_{sw}) is 500 kHz, then the external clock can have a frequency (f_{ext}) from 500 kHz to 1000 kHz. But, if the resistor connected at RT pin is selected such that the switching frequency (f_{sw}) is 1500 kHz, then the external clock can have a frequency (f_{ext}) from 1500 kHz to 2200 kHz only.

If the external clock goes off for less than 32 μ s, the NMOS switching FET is turned off and the output voltage starts decreasing. Depending upon the load conditions, the output voltage may hit the undervoltage threshold and reset threshold before the external clock appears. The NMOS switching FET stays OFF until the external clock appears again. If the output voltage hits the reset threshold, the $\overline{\text{RST}}$ pin is asserted low after a deglitch time of 20 μ s (typical).

If the external clock goes off for more than 32 μ s, the NMOS switching FET is turned off and the output voltage starts decreasing. Under this condition the default internal oscillator clock set by RT pin overrides the external after 32 μ s and the NMOS switching FET resumes switching. When the external clock appears again (such that $180 \text{ kHz} < f_{\text{sw}} < f_{\text{ext}} < 2 \times f_{\text{sw}} < 2.2 \text{ MHz}$), the NMOS switching FET starts switching at the frequency determined by the external clock.

7.3.7 Slew Rate Control

The slew rate of the NMOS switching FET can be set by using an external resistor (R7 in [Functional Block Diagram](#)). The range of rise times and fall times for different values of slew resistor are shown in [Figure 11](#) and [Figure 12](#).



7.3.8 Reset

The $\overline{\text{RST}}$ pin (pin 8) is an open-drain output pin used to indicate external digital devices and loads if the device has powered up to a programmed regulated output voltage properly. This pin is asserted low until the regulated output voltage (V_{Reg}) exceeds the programmed reset threshold ($V_{\text{REG_RST}}$, see [Equation 8](#)) and the reset delay timer (set by Cdly pin) has expired. Additionally, whenever the EN pin is low or open, $\overline{\text{RST}}$ is immediately asserted low regardless of the output voltage. There is a reset filter timer to prevent reset being invoked due to short negative transients on the output line. If thermal shutdown occurs due to excessive thermal conditions, this pin is asserted low when the switching FET is commanded OFF and the output falls below the reset threshold.

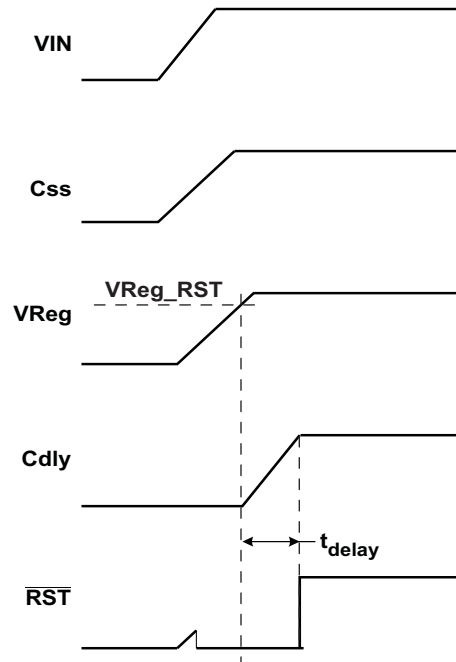


Figure 13. Power-On Condition and Reset Line

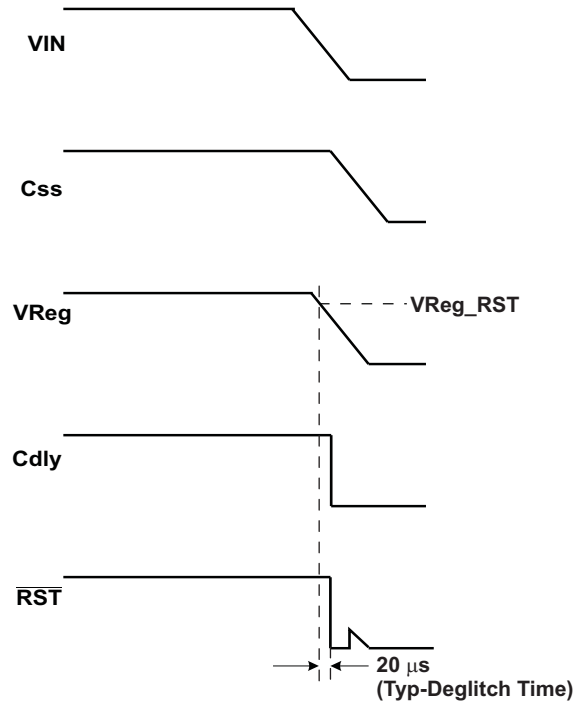


Figure 14. Power-Down Condition and Reset Line

7.3.9 Reset Delay

The delay time to assert the $\overline{\text{RST}}$ pin high after the supply has exceeded the programmed VReg_RST voltage (see Equation 8 to calculate VReg_RST) can be set by external capacitor (C_2 in *Functional Block Diagram*) connected to the Cdly pin (pin 9). The delay may be programmed in the range of 2.2 ms to 200 ms using a capacitor in the range of 2.2 nF to 200 nF. The delay time is calculated using Equation 6:

$$\text{PORdly} = \frac{1\text{ms}}{\text{nF}} \times \text{C}$$

where

- C = capacitor on Cdly pin (6)

7.3.10 Reset Threshold and Undervoltage Threshold

The undervoltage threshold (VReg_UV) level for proper regulation in low-power mode and the reset threshold level (VReg_RST) to initiate a reset output signal can be programmed by connecting an external resistor string to the RST_TH pin (pin 13). The resistor combination of R_1 , R_2 , and R_3 is used to program the threshold for detection of undervoltage. Voltage bias on $\text{R}_2 + \text{R}_3$ sets the reset threshold.

Undervoltage threshold for transient and low-power mode operation is given by the Equation 7. The recommended range for VReg_UV is 73% to 95% of VReg .

$$\text{VReg_UV} = \frac{\text{R}_1 + \text{R}_2 + \text{R}_3}{\text{R}_2 + \text{R}_3} \times 0.82 \text{ V} \quad (7)$$

Reset threshold is given by Equation 8. The recommended range for VReg_RST is 70% to 92% of VReg .

$$\text{VReg_RST} = \frac{\text{R}_1 + \text{R}_2 + \text{R}_3}{\text{R}_2 + \text{R}_3} \times 0.8 \text{ V} \quad (8)$$

7.3.11 Overvoltage Supervisor

The overvoltage monitoring of the regulated output voltage, VReg can be achieved by connecting an external resistor string to the OV_TH pin (pin 12). The resistor combination of R_1 , R_2 , and R_3 is used to program the threshold for detection of overvoltage. The bias voltage of R_3 sets the overvoltage threshold and the accuracy of regulated output voltage in hysteretic mode during transient events.

$$V_{\text{Reg_OV}} = \frac{R1+R2+R3}{R3} \times 0.8 \text{ V} \quad (9)$$

Recommended range for $V_{\text{Reg_OV}}$ is 106% to 110% of V_{Reg} .

7.3.12 Noise Filter on RST_TH and OV_TH Terminals

External capacitors may be required to filter the noise added to RST_TH and OV_TH terminals. The noise is more pronounced with fast falling edges on the PH pin. Therefore, selecting a smaller R_{slew} resistor ($R7$ in [Functional Block Diagram](#)) for a higher slew rate will require more external capacitance to filter the noise.

The RC time constant depends on external components ($R2$, $R3$, $C9$ and $C10$ in [Functional Block Diagram](#)) connected to RST_TH and OV_TH pins. For proper noise filtering, improved loop transient response and better short circuit protection, [Equation 10](#) must be satisfied.

$$(R2 + R3) \times (C9 + C10) < 2 \mu\text{s} \quad (10)$$

To meet this requirement, TI recommends to use lower values of external capacitors and resistors. The value of the time constant is also affected by the PCB capacitance and the application setup. Therefore, in some cases the external capacitors ($C9$, $C10$) on RST_TH and OV_TH terminals may not be required. Users can place a footprint on the application PCB and only populate it if necessary. Also, the external resistors ($R1$, $R2$, $R3$) must be sized appropriately to minimize any significant effect of board leakage.

For most cases, TI recommends keeping the external capacitors (either from board capacitance or by connecting external capacitors) between 10 pF to 100 pF; therefore, to meet time constant requirement in [Equation 10](#), the total external resistance ($R1 + R2 + R3$) should be less than 200 k Ω .

7.3.13 Boot Capacitor

An external boot strap capacitor ($C3$ in [Functional Block Diagram](#)) is connected to pin 20 (BOOT) to provide the gate drive voltage for the internal NMOS switching FET. TI recommends X7R or X5R grade dielectrics because of their stable values over temperature. The capacitor value may need to be adjusted higher for high V_{Reg} and/or low frequencies applications (for example, 100 nF for 500 kHz/5 V and 220 nF for 500 kHz/8 V).

7.3.14 Short Circuit Protection

The TPS54262-EP features an output short circuit protection. Short circuit conditions are detected by monitoring the RST_TH pin, and when the voltage on this node drops below 0.2 V, the switching frequency is decreased and current limit is folded back to protect the device. The switching frequency is folded back to approximately 25 kHz and the current limit is reduced to 30% of the typical current limit value.

7.3.15 Overcurrent Protection

The device features overcurrent protection to protect it from load currents greater than 2 A. Overcurrent protection is implemented by sensing the current through the NMOS switching FET. The sensed current is compared to a current reference level representing the overcurrent threshold limit (I_{CL}). If the sensed current exceeds the overcurrent threshold limit, the overcurrent indicator is set true. The system will ignore the overcurrent indicator for the leading edge blanking time at the beginning of each cycle to avoid any turnon noise glitches.

Once overcurrent indicator is set true, overcurrent protection is triggered. The NMOS switching FET is turned off for the rest of the cycle after a propagation delay. The overcurrent protection scheme is called cycle-by-cycle current limiting. If the sensed current continues to increase during cycle-by-cycle current limiting, the temperature of the part will start rising, the TSD will kick in and shutdown switching until the part cools down.

7.3.16 Internal Undervoltage Lockout (UVLO)

This device is enabled on power up once the internal bandgap and bias currents are stable; this happens typically at $V_{\text{IN}} = 3.4 \text{ V}$ (minimum). On power down, the internal circuitry is disabled at $V_{\text{IN}} = 2.6 \text{ V}$ (maximum).

7.3.17 Thermal Shutdown (TSD)

The TPS54262-EP protects itself from overheating with an internal thermal shutdown (TSD) circuit. If the junction temperature exceeds the thermal shutdown trip point, the NMOS switching FET is turned off. The device is automatically restarted under the control of soft-start circuit when the junction temperature drops below the thermal shutdown hysteretic trip point. During low-power mode operation, the thermal shutdown sensing circuitry is disabled for reduced current consumption. If V_{Reg} drops below V_{Reg_UV} , thermal shutdown monitoring is activated.

7.3.18 Loop Control Frequency Compensation – Type 3

Type 3 compensation has been used in the feedback loop to improve the stability of the convertor and regulation in the output in response to the changes in input voltage or load conditions. This becomes important because the ceramic capacitors used to filter the output have a low Equivalent Series Resistance (ESR). Type 3 compensation is implemented by connecting external resistors and capacitors to the COMP pin (output of the error amplifier, pin 15) of the device as shown in Figure 15.

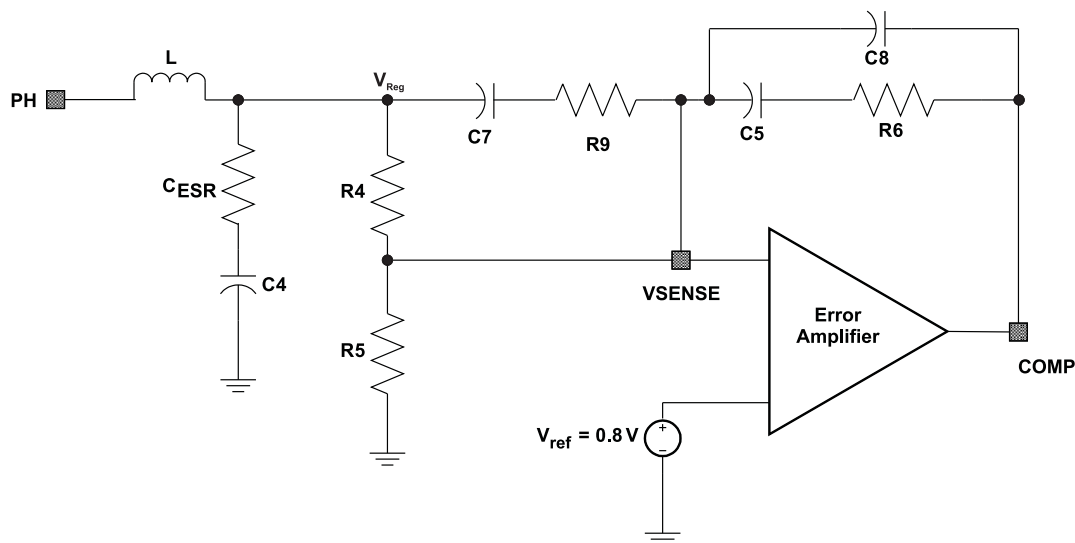


Figure 15. Type 3 Compensation

The crossover frequency should be less than 1/5th to 1/10th of the switching frequency, and should be greater than five times the double pole frequency of the LC filter.

$$f_c < f_{sw} \times (0.1 \text{ to } 0.2)$$

where

- f_{sw} = switching frequency (11)

The modulator break frequencies as a function of the output LC filter are derived from Equation 12 and Equation 13. The LC output filter gives a double pole that has a -180° phase shift.

$$f_{LC} = \frac{1}{2\pi\sqrt{LC}}$$

where

- L = output inductor
- C = output capacitor (C4 in functional block diagram) (12)

The ESR of the output capacitor C gives a ZERO that has a 90° phase shift.

$$f_{ESR} = \frac{1}{2\pi C \times ESR}$$

where

- ESR = Equivalent series resistance of a capacitor at a specified frequency (13)

The regulated output voltage, V_{Reg} is given by Equation 14.

$$V_{\text{Reg}} = V_{\text{ref}} \left(1 + \frac{R4}{R5} \right) \quad (14)$$

$$\frac{V_{\text{Reg}}}{0.8} = \frac{R4 + R5}{R5} \quad (15)$$

For $V_{\text{IN}} = 8 \text{ V}$ to 50 V , the $V_{\text{IN}}/V_{\text{ramp}}$ modulator gain is approximately 10 and has a tolerance of about 20%.

$$\text{Gain} = A_{\text{mod}} = \frac{V_{\text{IN}}}{V_{\text{ramp}}} = 10 \quad (16)$$

Therefore,

$$\text{Gain (dB)} = 20 \times \log\left(\frac{V_{\text{IN}}}{V_{\text{ramp}}}\right) = 20 \times \log(10) = 20 \text{ dB} \quad (17)$$

Also, V_{ramp} is fixed for the following range of V_{IN} . $V_{\text{ramp}} = 1 \text{ V}$ for $V_{\text{IN}} < 8 \text{ V}$, and $V_{\text{ramp}} = 5 \text{ V}$ for $V_{\text{IN}} > 48 \text{ V}$.

The frequencies for poles and zeros are given by following equations.

$$f_{p1} = \frac{(C5 + C8)}{2\pi \times R6 \times (C5 \times C8)} \quad (18)$$

$$f_{p2} = \frac{1}{2\pi \times R9 \times C7} \quad (19)$$

$$f_{z1} = \frac{1}{2\pi \times R6 \times C5} \quad (20)$$

$$f_{z2} = \frac{1}{2\pi \times (R4 + R9) \times C7} \quad (21)$$

Guidelines for selecting compensation components selection are provided in the [Application and Implementation](#) section of this document.

7.3.18.1 Bode Plot of Converter Gain

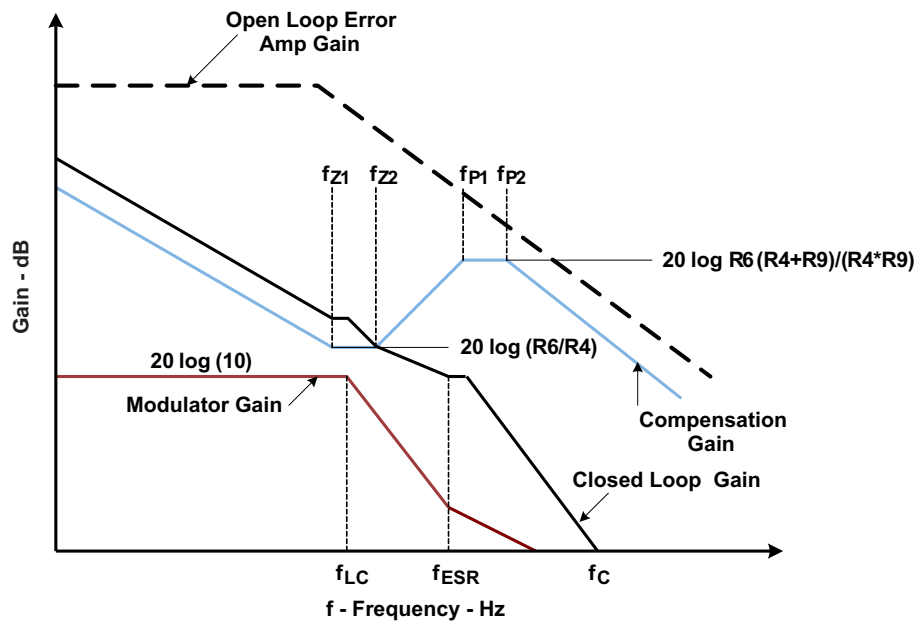


Figure 16. Bode Plot of Converter Gain Plot

7.4 Device Functional Modes

TPS54262-EP operates in the following modes based on the output loading conditions, input voltage, and LPM pin configuration. These operating conditions and modes of operations are shown in Figure 17.

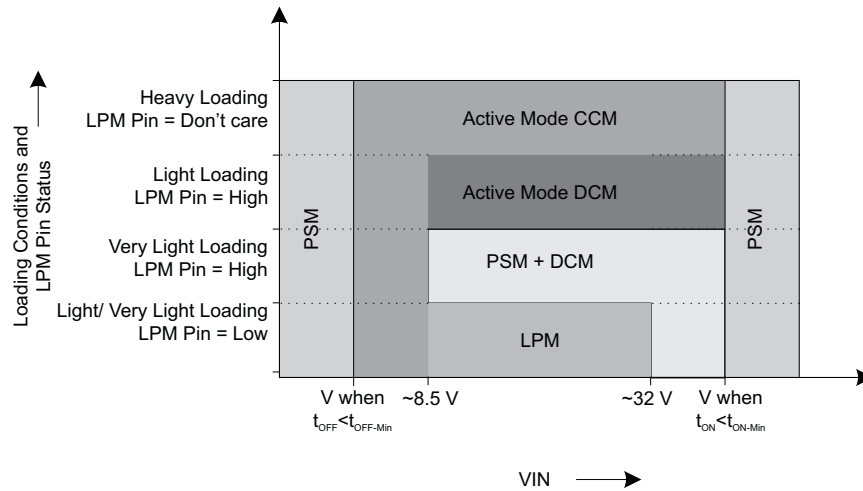


Figure 17. Modes of Operation

7.4.1 Active Mode Continuous Conduction Mode (CCM)

In this mode of operation the switcher operates in continuous conduction mode, and the inductor current is always non-zero if the total load current (internal and external) is greater than $I_{L_DISCONT}$ shown in Equation 22.

$$I_{L_DISCONT} = I_{L_LPM} = \frac{(1-D) \cdot V_{Reg}}{2 \cdot f_{sw} \cdot L}$$

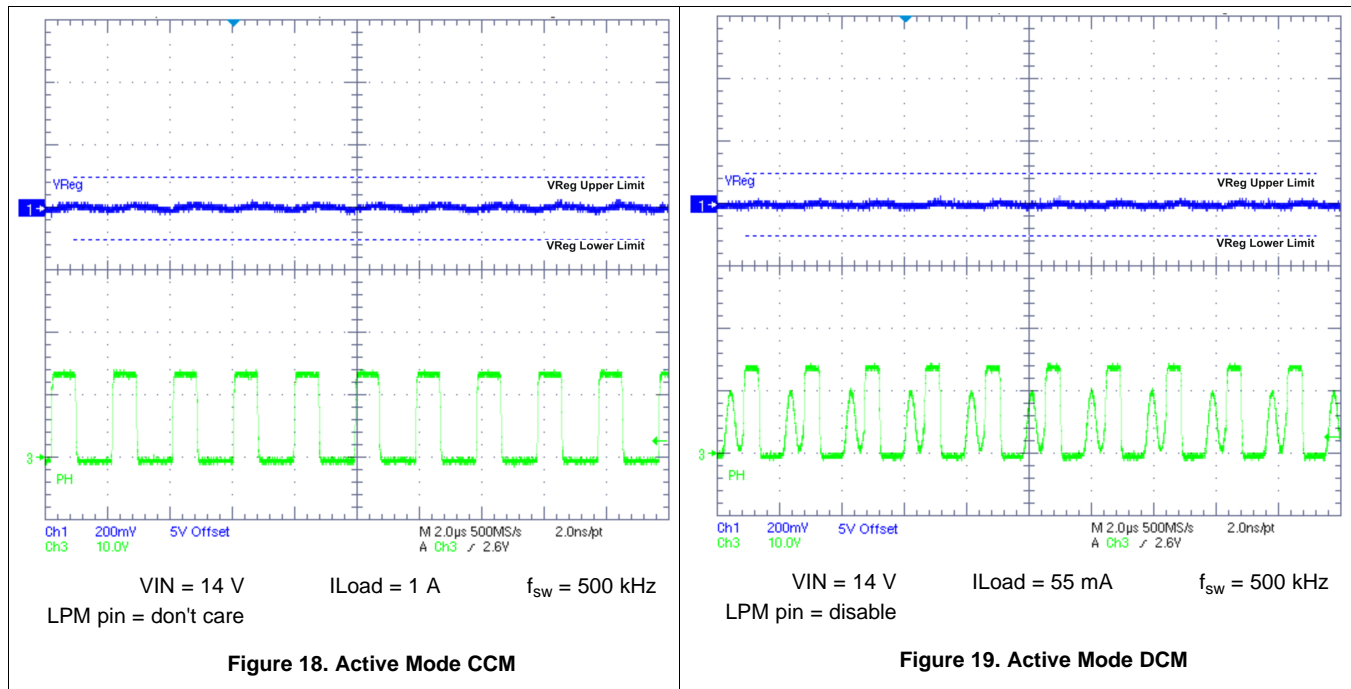
where

- D = duty cycle
- L = output inductor
- V_{Reg} = output voltage
- f_{sw} = switching frequency

(22)

For $V_{IN} < 8.5$ V, the device enables an internal approximately 100-Ω load. This, combined with the external load, can cause the device to enter into CCM even under light external loading conditions (see *Device Functional Modes*). This mode of operation is shown in Figure 18 is also called the Normal mode of operation.

Device Functional Modes (continued)



7.4.2 Active Mode Discontinuous Conduction Mode (DCM)

In this mode of operation the switcher operates in discontinuous conduction mode, and the inductor current becomes zero if the total load current (internal and external) is less than $I_{L_DISCONT}$ shown in Equation 23.

$$I_{L_DISCONT} = I_{L_LPM} = \frac{(1-D)V_{Reg}}{2 \cdot f_{sw} \cdot L} \tag{23}$$

The device enters in this mode of operation when LPM pin is set high (disabled) and output loading is less than $I_{L_DISCONT}$. This mode of operation is shown in Figure 19.

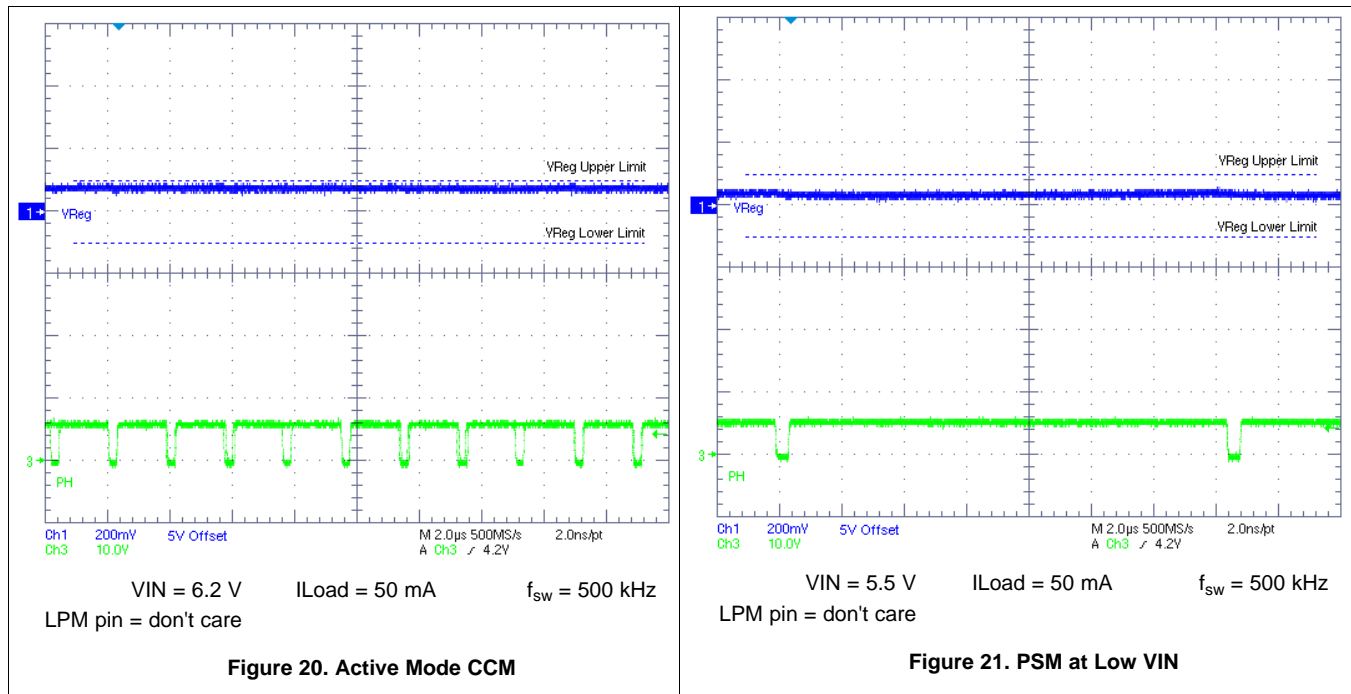
7.4.3 Pulse Skip Mode (PSM)

In this mode of operation the switcher operates in discontinuous conduction mode, and the inductor current becomes zero. The device enters in this mode of operation in the following conditions:

- At low input voltages when V_{Reg} starts losing regulation and the OFF time (t_{OFF}) of the switching FET tends to be close to or slightly less than the minimum OFF time ($t_{OFF-Min}$). If OFF time is much smaller than $t_{OFF-Min}$, there is a risk that the part stops switching and regulation is lost until power is re-cycled with OFF time greater than $t_{OFF-Min}$. This mode of operation is shown in Figure 21. Comparing Figure 20 and Figure 21, pulse skipping occurs in Figure 21 but not in Figure 20 under similar output loading conditions.

$$V_{IN} - I_{Load} \times R_{DS(ON)} < V_{Reg} \quad \text{and} \quad \left(1 - \frac{V_{Reg}}{V_{IN}}\right) \times \frac{1}{f_{sw}} > t_{OFF-Min} \tag{24}$$

Device Functional Modes (continued)



- Likewise, at higher input voltages when the ON time (t_{ON}) of the switching FET becomes close to or slightly less than the minimum ON time (t_{ON-Min}) and the V_{Reg} start losing regulation, the device enters in PSM. If ON time is much smaller than t_{ON-Min} , there is a risk that the part stops switching and regulation is lost until power is recycled with ON time greater than t_{ON-Min} .
- At nominal input voltages during very light output loading. This mode of operation is shown in [Figure 22](#). Comparing [Figure 19](#) and [Figure 22](#), in both cases the device is operating in discontinuous conduction mode; however, pulse skipping happens in [Figure 22](#) because of very light output loading for similar input voltage. LPM pin must be set high (disabled) for this to happen.

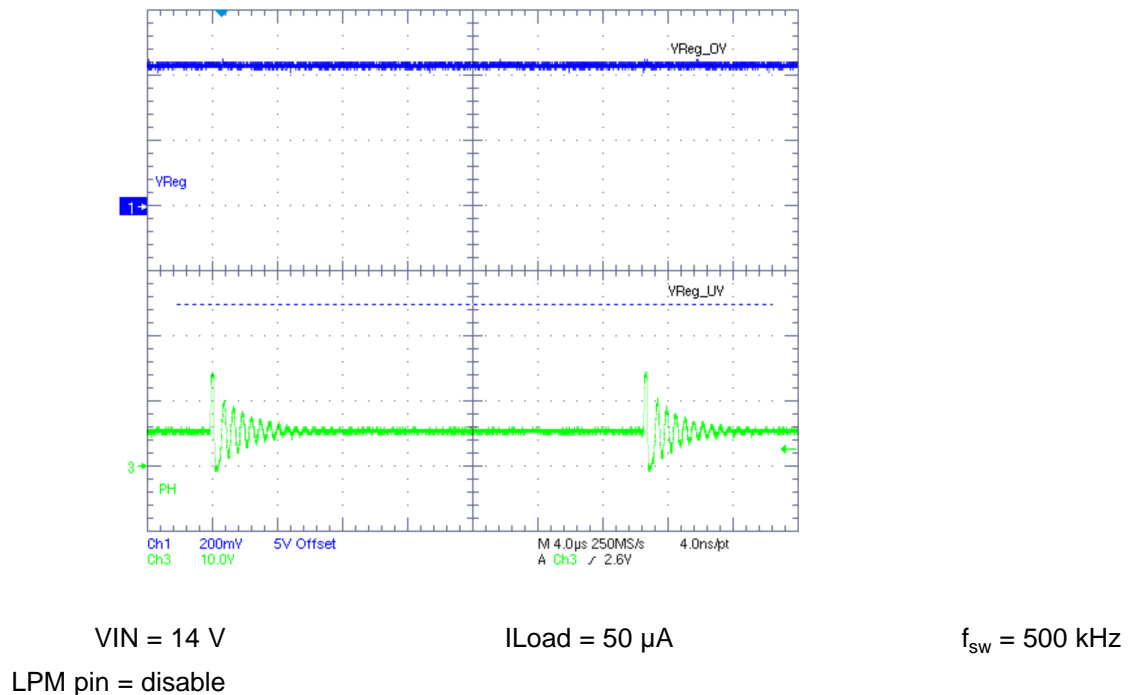
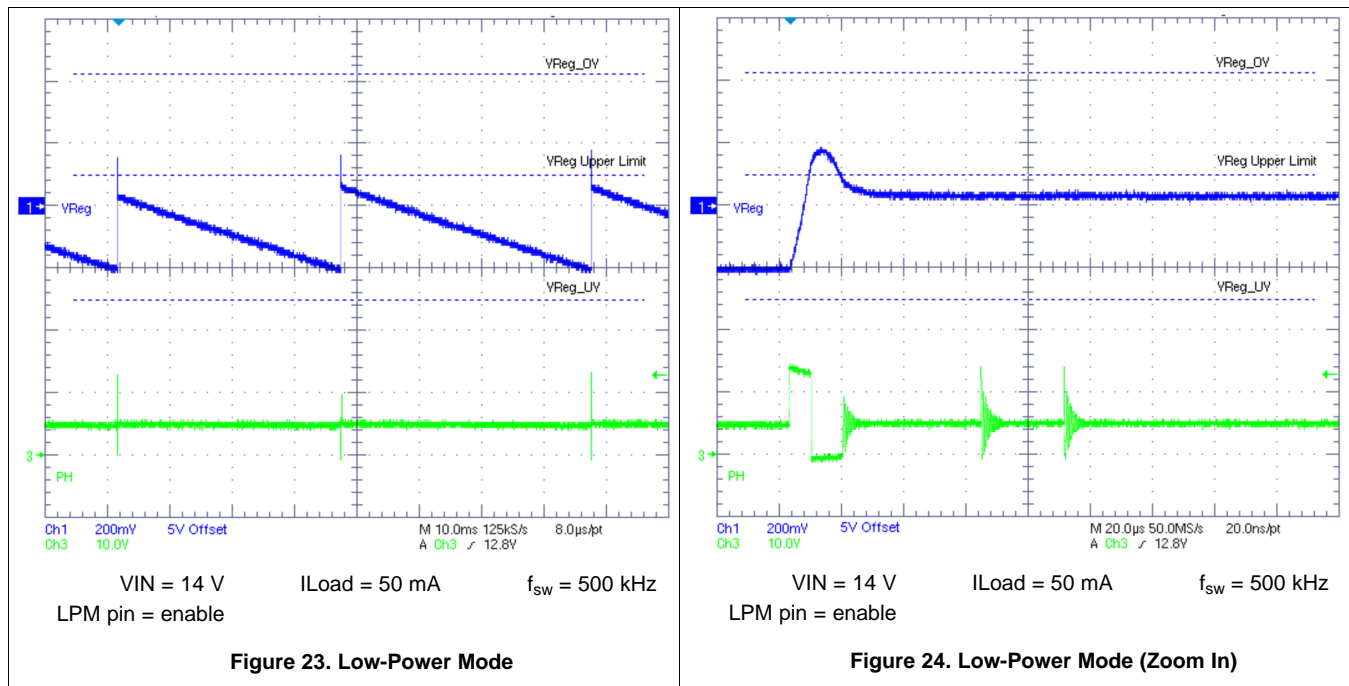


Figure 22. PSM at Nominal VIN

Device Functional Modes (continued)

7.4.4 Low-Power Mode (LPM)

In this mode of operation the device briefly operates in discontinuous conduction mode and then turns off until $V_{Reg} < V_{Reg_UV}$ threshold and this cycle is repeated. The LPM pin must be enabled to enable LPM mode of operation. When total load is less than $I_{L_DISCONT}$, the device operates in LPM for V_{IN} approximately 8.5 V to approximately 32 V. This mode of operation is shown in Figure 23 and Figure 24 (zoomed out).



Any transition from low-power mode to active mode CCM occurs within 5 μ s (typical). In low-power mode, the converter operates as a hysteretic controller with the threshold limits set by V_{Reg_UV} (see Equation 7, Functional Block Diagram and Figure 25), for the lower limit and approximately V_{Reg} for the upper limit. To ensure tight regulation in the low-power mode, R2 and R3 values are set accordingly (see discussion on Noise Filter on RST_TH and OV_TH Terminals). The device operates in both automatic (LPM pin is connected to ground) and digitally controlled (status of LPM pin is controlled by an external device, for example by a microcontroller) low-power mode. The digital low-power mode can over-ride the automatic low-power mode function by applying the appropriate signal on the LPM terminal. The part goes into active mode CCM for at least 100 μ s, whenever RST_TH or V_{Reg_UV} is tripped.

Table 2. LPM Pin Status

LPM PIN STATUS	MODES OF OPERATION
High	Device is forced in normal mode.
	At light loads, the device operates in DCM with a switching frequency determined by the external resistor connected to RT pin.
	At very light loads, the device operates in PSM with a reduced switching frequency (see Figure 17).
Low or open	Device automatically changes between normal mode and low-power mode depending on the load current.

Table 3. Modes of Operation

MODES OF OPERATION	DESCRIPTION
Normal mode (active mode)	All circuits including overvoltage threshold circuit (OV_TH) are enabled.
	At heavy loads, the device operates in continuous conduction mode irrespective of the status of LPM pin. OR At light loads, the device operates in discontinuous conduction mode (DCM) only if LPM pin is externally set high.
Low-power mode	OV_TH circuit is disabled. The device is in DCM, and LPM pin should be forced low.

When the device is operating in low-power mode, and if the output is shorted to ground, a reset is asserted. The thermal shutdown and current limiting circuitry is activated to protect the device. The LPM pin is active low and is internally pulled down; therefore, the low-power mode is automatically enabled unless this pin is driven high externally (for example, by a microcontroller) and the device is in continuous conduction mode. However, the low-power mode operation is initiated only when the device enters discontinuous mode of operation at light loads, and the LPM pin is low (or connected to ground).

7.4.5 Hysteretic Mode

The device enters in this mode of operation when the main loop fails to respond during line and load transients and regulate within specified tolerances. The device exits this mode of operation when the main control loop responds, after the error amplifier stabilizes, and controls the output voltage within tighter tolerance.

The power up conditions in different modes of operations are explained in [Table 4](#).

Table 4. Power-Up Conditions

MODE OF OPERATION	POWER-UP CONDITIONS
CCM	$V_{IN} > 3.6 \text{ V}$ (minimum)
LPM/DCM	$V_{Reg} < 5.5 \text{ V}$ and $(V_{IN} - V_{Reg}) > 2.5 \text{ V}$ (applicable only for $f_{sw} > 600 \text{ kHz}$)

7.4.6 Output Tolerances in Different Modes of Operation

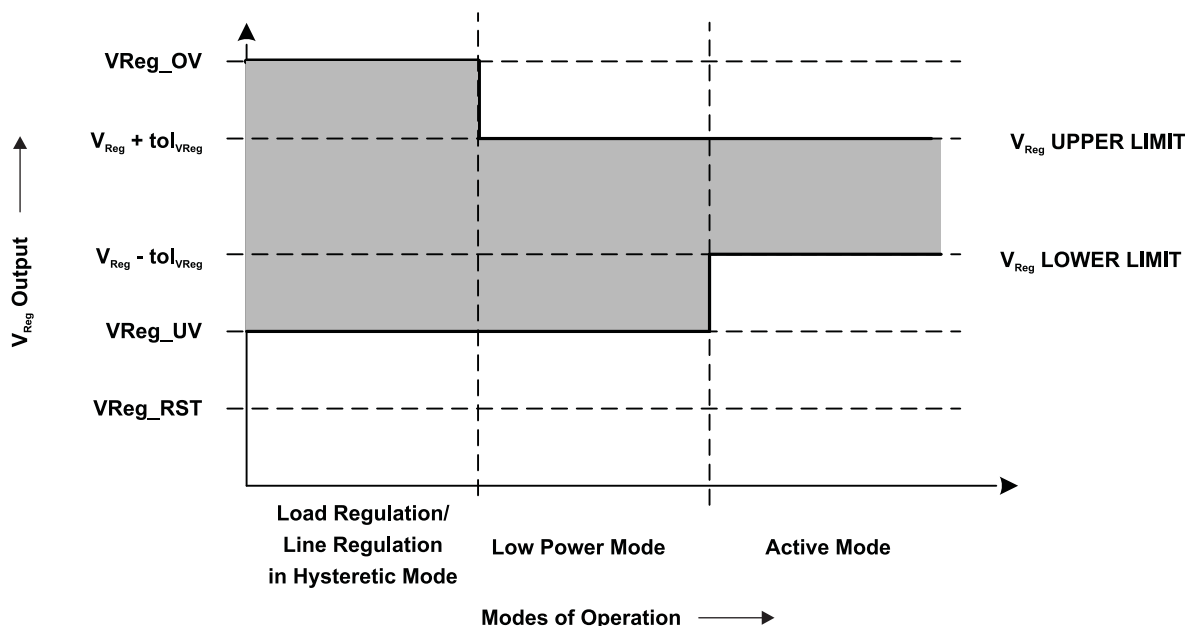


Figure 25. Output Tolerances Diagram

Table 5. Mode of Operation Descriptions

MODE OF OPERATION	V _{Reg} LOWER LIMIT	V _{Reg} UPPER LIMIT	COMMENTS
Hysteretic mode	VReg_UV	VReg_OV	Minimum to maximum ripple on output
Low-power mode	VReg_UV	V _{Reg} + tol _{VReg}	Minimum to maximum ripple on output
Active mode (Normal)	V _{Reg} - tol _{VReg}	V _{Reg} + tol _{VReg}	Minimum to maximum ripple on output

Table 6. Supervisor Thresholds Descriptions

SUPERVISOR THRESHOLDS	V _{Reg} TYPICAL VALUE	TOLERANCE	COMMENTS
VReg_OV	$\frac{R1+R2+R3}{R3} \times 0.8 \text{ V}$	$\pm (\text{tol}_{V\text{ref}} + \frac{R1 + R2}{R1 + R2 + R3}) \times (\text{tol}_{R1} + \text{tol}_{R2} + \text{tol}_{R3})$	Overtoltage threshold setting
VReg_RST	$\frac{R1+R2+R3}{R2+R3} \times 0.8 \text{ V}$	$\pm (\text{tol}_{V\text{ref}} + \frac{R1}{R1 + R2 + R3}) \times (\text{tol}_{R1} + \text{tol}_{R2} + \text{tol}_{R3})$	Reset threshold setting

8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

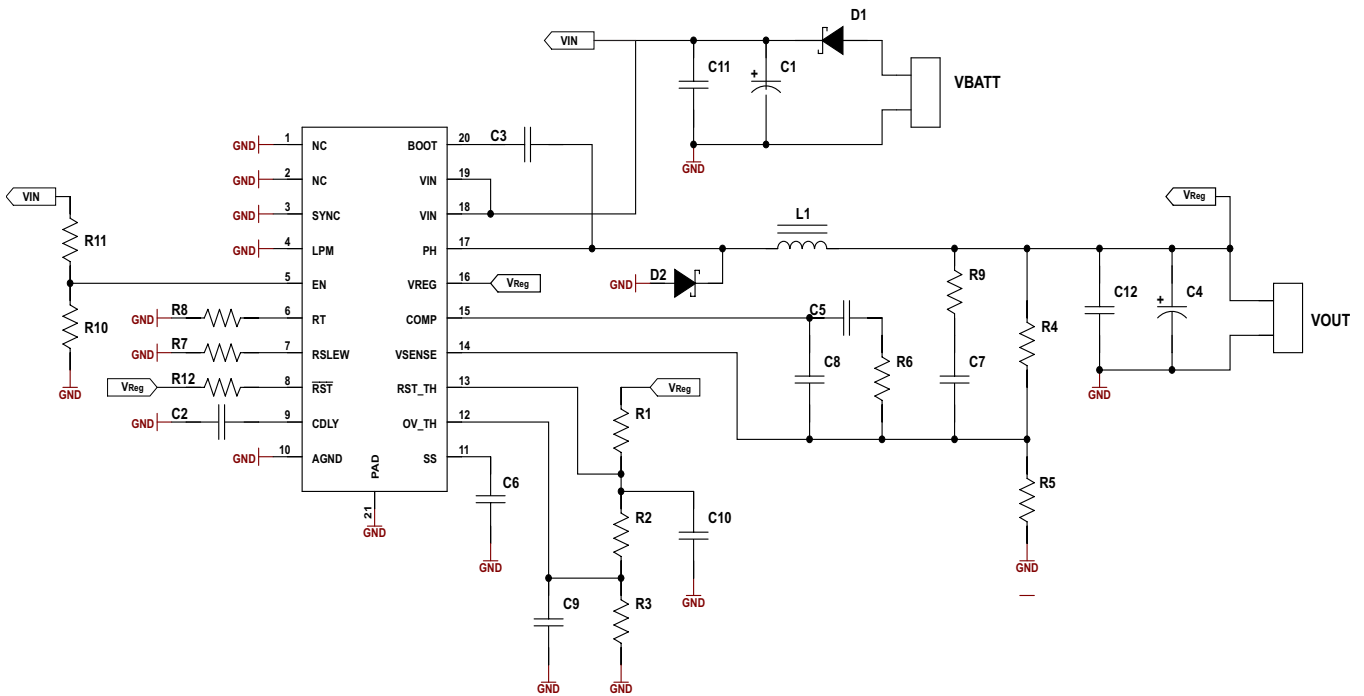
8.1 Application Information

The TPS54262-EP step-down DC-DC converter features an integrated NMOS switching FET and voltage supervisor circuit. It is designed to provide up to a 2-A output current from an input voltage source of 3.6 V to 48 V, and it can withstand transient voltages up to 60 V on its input pin. The device's input voltage line feed forward topology improves line transient regulation of the voltage mode buck regulator. The device also features low-power mode operation under light-load conditions, which reduces the supply current to 50 μ A (typical). It can work for wide switching frequency range (200 kHz to 2.2 MHz), which allows regulator design to be optimized for efficiency or solution size.

8.2 Typical Application

This section explains considerations for the external components selection. [Figure 26](#) shows the interconnection between external components and the device for a typical DC-DC step-down application.

The following examples demonstrate the design of a high frequency switching regulator using ceramic output capacitors. A few parameters must be known to start the design process. These parameters are typically determined at the system level.



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Figure 26. Typical Application Schematic

Typical Application (continued)

8.2.1 Design Requirements

The input voltage is supplied through VIN pins (pin 18 and 19), which must be externally protected against voltage levels greater than 60 V and reverse input polarity. An external diode is connected to protect these pins from reverse input polarity. The input current drawn from this pin is pulsed, with fast rise and fall times. Therefore, this input line requires a filter capacitor to minimize noise. Additionally, for EMI considerations, an input filter inductor may also be required.

For design considerations, VIN/VReg ratios must always be set such that the minimum required duty cycle pulse (t_{ON-Min}) is greater than 150 ns. The minimum off time ($t_{OFF-Min}$) is 250 ns for all conditions. The [Detailed Design Procedure](#) section provides the necessary equations and guidelines for selecting external components for this regulator.

8.2.2 Detailed Design Procedure

8.2.2.1 Component Selection

8.2.2.1.1 Input Capacitors (C1, C11)

Input filter capacitor (C11) is used to filter out high frequency noise in the input line. Typical values of C11 are 0.1 μ F to 0.01 μ F. For higher frequency noise, low capacitor values are recommended.

To minimize the ripple voltage, input ceramic de-coupling capacitor (C1) of type X5R or X7R should be used. The DC voltage rating for the input decoupling capacitor must be greater than the maximum input voltage. This capacitor must have an input ripple current rating higher than the maximum input ripple current of the converter for the application; and is determined by [Equation 25](#).

$$I_{RMS} = I_{Load} \sqrt{\frac{V_{Reg}(V_{IN_{Min}} - V_{Reg})}{V_{IN_{Min}}^2}} \quad (25)$$

The input capacitors for power regulators are chosen to have a reasonable capacitance-to-volume ratio and fairly stable over temperature. The value of the input capacitance also determines the input ripple voltage of the regulator, shown by [Equation 26](#).

$$\Delta V_{IN} = \frac{0.25 \times I_{Load-Max}}{C1 \times f_{SW}} \quad (26)$$

Input ceramic filter capacitors should be located in close proximity to the VIN terminal. Surface mount capacitors are recommended to minimize lead length and reduce noise coupling.

8.2.2.1.2 Output Capacitor (C4, C12)

The selection of the output capacitor will determine several parameters in the operation of the converter (for example, voltage drop on the output capacitor and the output ripple). The capacitor value also determines the modulator pole and the roll-off frequency due to the LC output filter double pole. This is expressed in [Equation 12](#).

The minimum capacitance needed to maintain desired output voltage during high to low load transition and prevent over shoot is given by [Equation 27](#).

$$C4 = \frac{L \times (I_{Load-Max}^2 - I_{Load-Min}^2)}{V_{Reg-Max}^2 - V_{Reg-Min}^2}$$

where

- L = output inductor
- $I_{Load-Max}$ = maximum load current
- $I_{Load-Min}$ = minimum load current
- $V_{Reg-Max}$ = maximum tolerance of regulated output voltage
- $V_{Reg-Min}$ = minimum tolerance of regulated output voltage

(27)

Typical Application (continued)

During a load step from no load to full load or changes in the input voltage, the output capacitor must hold up the output voltage above a certain level for a specified time and not issue a reset, until the main regulator control loop responds to the change. The minimum output capacitance required to allow sufficient drop on the output voltage without issuing a reset is determined by [Equation 28](#).

$$C4 > \frac{2 \times \Delta I_{\text{Load}}}{f_{\text{SW}} \times \Delta V_{\text{Reg}}}$$

where

- ΔV_{Reg} = transient response during load stepping (28)

The minimum capacitance needed for output voltage ripple specification is given by [Equation 29](#).

$$C4 > \frac{1}{8 \times f_{\text{SW}} \times \frac{V_{\text{Reg-Ripple}}}{I_{\text{Ripple}}}}$$

Additional capacitance deratings for temperature, aging, and DC bias must be factored in, and so a value of 100 μF with ESR calculated using [Equation 30](#) of less than 100 m Ω should be used on the output stage.

Maximum ESR of the output capacitor is based on output ripple voltage specification in [Equation 30](#). The output ripple voltage is a product of the output capacitor ESR and ripple current.

$$R_{\text{ESR}} < \frac{V_{\text{Reg-Ripple}}}{I_{\text{Ripple}}}$$

Output capacitor root mean square (RMS) ripple current is given by [Equation 31](#). This is to prevent excess heating or failure due to high ripple currents. This parameter is sometimes specified by the manufacturers.

$$I_{\text{Load-RMS}} = \frac{V_{\text{Reg}} (V_{\text{IN}_{\text{Max}}} - V_{\text{Reg}})}{\sqrt{12} \times V_{\text{IN}_{\text{Max}}} \times f_{\text{sw}} \times L1}$$

Filter capacitor (C12) of value 0.1 μF (typical) is used to filter out the noise in the output line.

8.2.2.1.3 Soft-Start Capacitor (C6)

The soft-start capacitor determines the minimum time to reach the desired output voltage during a power-up cycle. This is useful when a load requires a controlled voltage slew rate, and helps to limit the current draw from the input voltage supply line. TI recommends a 100-nF capacitor for start-up loads of 1 A (maximum).

8.2.2.1.4 Bootstrap Capacitor (C3)

A 0.1- μF ceramic capacitor must be connected between the PH and BOOT terminals for the converter to operate and regulate to the desired output voltage. TI recommends using a capacitor with X5R or better grade dielectric material, and the voltage rating on this capacitor of at least 25 V to allow for derating.

8.2.2.1.5 Power-On Reset Delay (PORdly) Capacitor (C2)

The value of this capacitor can be calculated using [Equation 6](#).

8.2.2.1.6 Output Inductor (L1)

Use a low EMI inductor with a ferrite type shielded core. Other types of inductors may be used; however, they must have low EMI characteristics and should be placed away from the low-power traces and components in the circuit.

Typical Application (continued)

To calculate the minimum value of the inductor, the ripple current should be first calculated using [Equation 32](#).

$$I_{\text{Ripple}} = K_{\text{IND}} \times I_{\text{Load}}$$

where

- I_{Load} = maximum output load current
- I_{Ripple} = allowable peak to peak inductor ripple current, typically 20% of maximum I_{Load}
- K_{IND} = coefficient that represents the amount of inductor ripple current relative to the maximum output current. (32)

The inductor ripple current is filtered by the output capacitor; therefore, K_{IND} is typically in the range of 0.2 to 0.3, depending on the ESR and the ripple current rating of the output capacitor (C4).

The minimum value of output inductor can be calculated using [Equation 33](#).

$$L_{\text{Min}} = \frac{(V_{\text{IN}_{\text{Max}}} - V_{\text{Reg}}) \times V_{\text{Reg}}}{f_{\text{sw}} \times I_{\text{Ripple}} \times V_{\text{IN}_{\text{Max}}}}$$

where

- $V_{\text{IN}_{\text{Max}}}$ = maximum input voltage
- V_{Reg} = regulated output voltage
- f_{sw} = switching frequency (33)

The RMS and peak currents flowing in the inductor are given by [Equation 34](#) and [Equation 35](#).

$$I_{\text{L,RMS}} = \sqrt{I_{\text{Load}}^2 + \frac{I_{\text{Ripple}}^2}{12}} \quad (34)$$

$$I_{\text{L,pk}} = I_{\text{Load}} + \frac{I_{\text{Ripple}}}{2} \quad (35)$$

8.2.2.1.7 Flyback Schottky Diode (D2)

The TPS54262-EP requires an external Schottky diode connected between the PH and power ground termination. The absolute voltage at PH pin should not go beyond the values in [Absolute Maximum Ratings](#). The Schottky diode conducts the output current during the off state of the internal power switch. This Schottky diode must have a reverse breakdown voltage higher than the maximum input voltage of the application. A Schottky diode is selected for its lower forward voltage. The Schottky diode is selected based on the appropriate power rating, which factors in the DC conduction losses and the AC losses due to the high switching frequencies; this is determined by [Equation 36](#).

$$P_{\text{diode}} = \frac{(V_{\text{IN}_{\text{Max}}} - V_{\text{Reg}}) \times I_{\text{Load}} \times V_{\text{fd}}}{V_{\text{IN}_{\text{Max}}}} + \frac{(V_{\text{IN}} - V_{\text{fd}})^2 \times f_{\text{sw}} \times C_{\text{J}}}{2}$$

where

- P_{diode} = power rating
- V_{fd} = forward conducting voltage of Schottky diode
- C_{J} = junction capacitance of the Schottky diode (36)

Recommended part numbers are PDS 360 and SBR8U60P5.

8.2.2.1.8 Resistor to Set Slew Rate (R7)

The slew rate setting is asymmetrical; that is, for a selected value of R7, the rise time and fall time are different. R7 can be approximately determined from [Figure 11](#) and [Figure 12](#). The minimum recommended value is 10 kΩ.

8.2.2.1.9 Resistor to Select Switching Frequency (R8)

See [Selecting the Switching Frequency](#), [Figure 10](#) and [Equation 4](#).

Typical Application (continued)

8.2.2.1.10 Resistors to Select Output Voltage (R4, R5)

To minimize the effect of leakage current on the VSENSE terminal, the current flowing through the feedback network should be greater than 5 mA to maintain output accuracy. Higher resistor values help improve the converter efficiency at low-output currents, but may introduce noise immunity problems. See [Equation 1](#). TI recommends fixing R4 to a standard value (for example, 187 kΩ) and calculate R5.

8.2.2.1.11 Resistors to Set Undervoltage, Overvoltage, and Reset Thresholds (R1, R2, R3)

8.2.2.1.11.1 Overvoltage Resistor Selection

Using [Equation 9](#), the value of R3 can be determined to set the overvoltage threshold at up to 106% to 110% of V_{Reg} . The sum of R1, R2, and R3 resistor network to ground should be approximately 100 kΩ.

8.2.2.1.11.2 Reset Threshold Resistor Selection

Using [Equation 8](#) the value of R2 + R3 can be calculated, and knowing R3 from the OV_TH setting, R2 can be determined. Suggested value of reset threshold is 92% of V_{Reg} .

8.2.2.1.11.3 Undervoltage Threshold for Low-Power Mode and Load Transient Operation

This threshold is set above the reset threshold to ensure the regulator operates within the specified tolerances during output load transient of low load to high load and during discontinuous conduction mode. The typical voltage threshold can be determined using [Equation 7](#). Suggested value of undervoltage threshold is 95% of V_{Reg} .

8.2.2.1.12 Low-Power Mode (LPM) Threshold

An approximation of the output load current at which the converter is operating in discontinuous mode can be obtained from [Equation 23](#) with $\pm 30\%$ hysteresis. The values used in [Equation 3](#) for minimum and maximum input voltage will affect the duty cycle and the overall discontinuous mode load current. These are the nominal values, and other factors are not taken into consideration like external component variations with temperature and aging.

8.2.2.1.13 Enable Pin Pull-Up Resistor (R11) and Voltage Divider Resistor (R10)

An external pull-up resistor, R11= 30.1 kΩ, is recommended to enable the device for operation and R10 can be left open.

Based on the application needs, if the device needs to be turned on at certain input voltage using EN pin threshold, R10 can be used as a voltage divider resistor along with pull-up resistor (R11=30.1 kΩ) and R10 can be calculated accordingly.

8.2.2.1.14 Pull-Up Resistor (R12) at \overline{RST} Pin

A standard pull-up resistor, R12 = 2 K Ω can be used at this pin

8.2.2.1.15 Type 3 Compensation Components (R5, R6, R9, C5, C7, C8)

First, make the ZEROs close to double pole frequency, using [Equation 12](#), [Equation 13](#), and [Equation 11](#).

$$fz1 = (50\% \text{ to } 70\%) f_{LC}$$

$$fz2 = f_{LC}$$

Second, make the POLEs above the crossover frequency, using [Equation 18](#) and [Equation 19](#).

$$fp1 = f_{ESR}$$

$$fp2 = \frac{1}{2}f_{sw}$$

8.2.2.1.15.1 Resistors

From [Equation 1](#), knowing V_{Reg} and R4 (fix to a standard value), R5 can be calculated as shown in [Equation 37](#):

$$R5 = \frac{R4}{\frac{V_{Reg}}{V_{ref}} - 1}$$

(37)

Typical Application (continued)

Using Equation 11 and Equation 15, R6 can be calculated as shown in Equation 38:

$$R6 = \frac{f_c \times V_{Ramp} \times R4}{VIN \times f_{LC}} \quad (38)$$

R9 can be calculated as shown in Equation 39:

$$R9 = \frac{R4}{\left(\frac{f_{sw}}{2f_{LC}} - 1\right)} \quad (39)$$

8.2.2.1.15.2 Capacitors

Using Equation 20, C5 can be calculated as shown in Equation 40:

$$C5 = \frac{1}{\pi \times R6 \times f_{LC}} \quad (40)$$

C7 can be calculated as shown in Equation 41:

$$C7 = \frac{1}{\pi \times R9 \times f_{sw}} \quad (41)$$

C8 can be calculated as shown in Equation 42:

$$C8 = \frac{C5}{2\pi \times R6 \times C5 \times f_{ESR} - 1} \quad (42)$$

8.2.2.1.16 Noise Filter on RST_TH and OV_TH Terminals (C9, C10)

These capacitors may be required in some applications to filter the noise on RST_TH and OV_TH pins. Typical capacitor values for RST_TH and OV_TH pins are from 10 pF to 100 pF for total resistance on RST_TH/OV_TH divider of less than 200 kΩ. See [Noise Filter on RST_TH and OV_TH Terminals](#).

8.2.2.2 Design Example 1

For this example, we will start with the following known and target parameters:

Table 7. Design Parameters – Example 1⁽¹⁾

PARAMETER TYPE	PARAMETER NAME	PARAMETER VALUE
Known	Input voltage, VIN	Minimum = 8 V, Maximum = 28 V, Typical = 14 V
	Output voltage, V _{Reg}	5 V ± 2%
Target	Maximum output current, I _{Load-Max}	1.8 A
	Ripple/ transient occurring in input voltage, ΔVIN	1% of VIN (minimum)
	Reset threshold, V _{Reg_RST}	92% of V _{Reg}
	Overvoltage threshold, V _{Reg_OV}	106% of V _{Reg}
	Undervoltage threshold, V _{Reg_UV}	95% of V _{Reg}
	Transient response 0.25 A to 2-A load step, ΔV _{Reg}	5% of V _{Reg}
	Power-on Reset delay, POR _{dy}	2.2 ms

(1) For the circuit diagram, see [Figure 26](#).

8.2.2.2.1 Calculate the Switching Frequency (f_{sw})

To reduce the size of output inductor and capacitor, higher switching frequency can be selected. It is important to understand that higher switching frequency results in higher switching losses, causing the device to heat up. This may result in degraded thermal performance. To prevent this, proper PCB layout guidelines must be followed (see [Layout Guidelines](#)).

Based upon the discussion in section [Selecting the Switching Frequency](#), calculate the maximum and minimum duty cycle.

Knowing V_{Reg} and tolerance on V_{Reg} , the $V_{Reg-Max}$ and $V_{Reg-Min}$ are calculated to be:

$$V_{Reg-Max} = 102\% \text{ of } V_{Reg} = 5.1 \text{ V and } V_{Reg-Min} = 98\% \text{ of } V_{Reg} = 4.9 \text{ V.}$$

Using [Equation 3](#), the minimum duty cycle is calculated to be, $D_{Min} = 17.5\%$

Knowing: $t_{ON-Min} = 150 \text{ ns}$ from the device specifications, and using [Equation 4](#), maximum switching frequency is calculated to be, $f_{sw-Max} = 1166 \text{ kHz}$

Because the oscillator can also vary by $\pm 10\%$, the switching frequency can be further reduced by 10% to add margin. Also, to improve efficiency and reduce power losses due to switching, the switching frequency can be further reduced by about 550 kHz. Therefore, $f_{sw} = 500 \text{ kHz}$.

From [Figure 10](#), R8 can be approximately determined to be, $R8 = 205 \text{ k}\Omega$.

8.2.2.2.2 Calculate the Ripple Current (I_{Ripple})

Using [Equation 32](#), for $K_{IND} = 0.2$ (typical), inductor ripple current is calculated to be: $I_{Ripple} = 0.36 \text{ A}$.

The ripple current is chosen such that the converter enters discontinuous mode (DCM) at 20% of maximum load. The 20% is a typical value, it could go higher to a maximum of up to 40%.

8.2.2.2.3 Calculate the Inductor Value (L1)

Using [Equation 33](#), the inductor value is calculated to be, $L_{Min} = 22.8 \mu\text{H}$. A closest standard inductor value can be used.

8.2.2.2.4 Calculate the Output Capacitor and ESR (C4)

8.2.2.2.4.1 Calculate Capacitance

To calculate the capacitance of the output capacitor, first determine the minimum load current. Typically, in standby mode the load current is $100 \mu\text{A}$; however, this really depends on the application. With this value of minimum load current and using [Equation 27](#), [Equation 28](#), and [Equation 29](#), C4 is calculated to be, $C4 > 34 \mu\text{F}$.

To allow wider operating conditions and improved performance in low-power mode, TI recommends using a $100\text{-}\mu\text{F}$ capacitor. A higher value of the output capacitor allows improved transient response during load stepping.

8.2.2.2.4.2 Calculate ESR

Using [Equation 30](#), ESR is calculated to be, $R_{ESR} < 555 \text{ m}\Omega$.

Capacitors with lowest ESR values should be selected. To meet both the requirements, capacitance and low ESR, several low ESR capacitors may be connected in parallel. In this example, we will select a capacitor with ESR value as $30 \text{ m}\Omega$.

Filter capacitor (C12) of value $0.1 \mu\text{F}$ can be added to filter out the noise in the output line.

8.2.2.2.5 Calculate the Feedback Resistors (R4, R5)

To keep the quiescent current low and avoid instability problems, TI recommends selecting R4 and R5 such that, $R4 + R5$ is approximately $250 \text{ k}\Omega$.

Using [Equation 1](#) and using a fixed standard value of $R4 = 187 \text{ k}\Omega$, R5 is calculated to be, $R5 = 35.7 \text{ k}\Omega$.

8.2.2.2.6 Calculate Type 3 Compensation Components

8.2.2.2.6.1 Resistances (R6, R9)

Using [Equation 16](#), for $V_{IN-Typ} = 14 \text{ V}$, V_{Ramp} is calculated to be, $V_{Ramp} = 1.4 \text{ V}$.

Using [Equation 12](#), f_{LC} is calculated to be, $f_{LC} = 3.33 \text{ kHz}$.

Using V_{Ramp} , f_{LC} from above, assuming f_c as 1/10th of f_{sw} and Equation 38, R6 is calculated to be, $R6 = 280.65 \text{ k}\Omega$.

Using Equation 39, R9 is calculated to be, $R9 = 2.53 \text{ k}\Omega$.

8.2.2.2.6.2 Capacitors (C5, C8, C7)

Using Equation 40, C5 is calculated to be, $C5 = 340.45 \text{ pF}$.

Using Equation 13, f_{ESR} is calculated to be, $f_{\text{ESR}} = 53.06 \text{ kHz}$.

Using Equation 42, C8 is calculated to be, $C8 = 11.04 \text{ pF}$.

Using Equation 41, C7 is calculated to be, $C7 = 250.07 \text{ pF}$.

8.2.2.2.7 Calculate Soft-Start Capacitor (C6)

The recommended value of soft-start capacitor is 100 nF (typical).

8.2.2.2.8 Calculate Bootstrap Capacitor (C3)

The recommended value of bootstrap capacitor is 0.1 μF (typical).

8.2.2.2.9 Calculate Power-On Reset Delay Capacitor (C2)

To achieve 2.2-ms delay, the reset delay capacitor can be calculated using Equation 6 to be $C2 = 2.2 \text{ nF}$.

8.2.2.2.10 Calculate Input Capacitor (C1, C11)

Typical values for C11 are 0.1 μF and 0.01 μF .

Input capacitor (C1) should be rated more than the maximum input voltage ($V_{\text{IN}_{\text{Max}}}$). The input capacitor should be big enough to maintain supply in case of transients in the input line. Using Equation 26, C1 is calculated to be, $C1 = 1.2 \text{ }\mu\text{F}$. For improved transient response, TI recommends a higher value of C1 such as 220 μF .

8.2.2.2.11 Calculate Resistors to Control Slew Rate (R7)

The value of slew rate resistor (R7) can be approximately determined from Figure 11 and Figure 12 at different typical input voltages. The minimum recommended value is 10 $\text{k}\Omega$. To achieve rise time, $t_r = 20 \text{ ns}$ and fall time, $t_f = 35 \text{ ns}$, the slew rate resistor is approximately of value 30 $\text{k}\Omega$.

8.2.2.2.12 Resistors to Select Undervoltage, Overvoltage and Reset Threshold Values (R1, R2, R3)

The sum of these three resistors should be approximately equal to 100 $\text{k}\Omega$. In this example,

- $V_{\text{Reg_OV}} = 106\%$ of $V_{\text{Reg}} = 5.3 \text{ V}$
- $V_{\text{Reg_RST}} = 92\%$ of $V_{\text{Reg}} = 4.6 \text{ V}$
- $V_{\text{Reg_UV}} = 95\%$ of $V_{\text{Reg}} = 4.75 \text{ V}$

Using Equation 9, $R3 = 15 \text{ k}\Omega$.

Using Equation 8, $R2 = 2.29 \text{ k}\Omega$.

Using Equation 7, $R1 = 82.6 \text{ k}\Omega$

8.2.2.2.13 Diode D1 and D2 Selection

Diode D1 is used to protect the IC from the reverse input polarity connection. The diode should be rated at maximum load current. Only Schottky diode should be connected at the PH pin. The recommended part numbers are PDS360 and SBR8U60P5.

8.2.2.2.14 Noise Filter on RST_TH and OV_TH Terminals (C9 and C10)

Typical capacitor values for RST_TH and OV_TH pins are from 10 pF to 100 pF for total resistance on RST_TH/OV_TH divider of less than 200 $\text{k}\Omega$.

8.2.2.2.15 Power Budget and Temperature Estimation

Using Equation 43, conduction losses for typical input voltage are calculated to be, $P_{CON} = 0.289 \text{ W}$.

Assuming slew resistance $R7 = 30 \text{ k}\Omega$, from Figure 11 and Figure 12, rise time, $t_r = 20 \text{ ns}$ and fall time, $t_f = 35 \text{ ns}$. Using Equation 44, switching losses for typical input voltage are calculated to be, $P_{SW} = 0.693 \text{ W}$.

Using Equation 45, gate drive losses are calculated to be, $P_{Gate} = 3 \text{ mW}$.

Using Equation 46, power supply losses are calculated to be, $P_{IC} = 1.8 \text{ mW}$.

Using Equation 47, the total power dissipated by the device is calculated to be, $P_{Total} = 987 \text{ mW}$.

Using Equation 49, and knowing the thermal resistance of package = 35°C/W , the rise in junction temperature due to power dissipation is calculated to be, $\Delta T = 34.5^\circ\text{C}$.

Using Equation 50, for a given maximum junction temperature 150°C , the maximum ambient temperature at which the device can be operated is calculated to be, $T_{A-Max} = 115^\circ\text{C}$ (approximately).

8.2.2.3 Design Example 2

For this example, start with the following known and target parameters:

Table 8. Design Parameters – Example 2⁽¹⁾

PARAMETER TYPE	PARAMETER NAME	PARAMETER VALUE
Known	Input voltage, V_{IN}	Minimum = 8 V, Maximum = 28 V, Typical = 14 V
Target	Output voltage, V_{Reg}	3.3 V \pm 2%
	Maximum output current, $I_{Load-Max}$	2 A
	Ripple/ transient occurring in input voltage, ΔV_{IN}	1% of V_{IN} (minimum)
	Reset threshold, V_{Reg_RST}	92% of V_{Reg}
	Overvoltage threshold, V_{Reg_OV}	106% of V_{Reg}
	Undervoltage threshold, V_{Reg_UV}	95% of V_{Reg}
	Transient response 0.25-A to 2-A load step, ΔV_{Reg}	5% of V_{Reg}
	Power on Reset delay, $PORdly$	2.2 ms

(1) For the circuit diagram, see Figure 26.

8.2.2.3.1 Calculate the Switching Frequency (f_{sw})

To reduce the size of output inductor and capacitor, higher switching frequency can be selected. It is important to understand that higher switching frequency results in higher switching losses, causing the device to heat up. This may result in degraded thermal performance. To prevent this, proper PCB layout guidelines must be followed (see Layout Guidelines).

Based upon the discussion in section *Selecting the Switching Frequency*, calculate the maximum and minimum duty cycle.

Knowing V_{Reg} and tolerance on V_{Reg} , the $V_{Reg-Max}$ and $V_{Reg-Min}$ are calculated to be:

$$V_{Reg-Max} = 102\% \text{ of } V_{Reg} = 3.366 \text{ V and } V_{Reg-Min} = 98\% \text{ of } V_{Reg} = 3.234 \text{ V.}$$

Using Equation 3, the minimum duty cycle is calculated to be, $D_{Min} = 11.55\%$

Knowing $t_{ON-Min} = 150 \text{ ns}$ from the device specifications, and using Equation 4, maximum switching frequency is calculated to be, $f_{sw-Max} = 770 \text{ kHz}$.

Because the oscillator can also vary by $\pm 10\%$, the switching frequency can be further reduced by 10% to add margin. Also, to improve efficiency and reduce power losses due to switching, the switching frequency can be further reduced by about 100 kHz. Therefore $f_{sw} = 593$ kHz.

From [Figure 10](#), R8 can be approximately determined to be, $R8 = 170$ k Ω .

8.2.2.3.2 Calculate the Ripple Current (I_{Ripple})

Using [Equation 32](#), for $K_{IND} = 0.2$ (typical), inductor ripple current is calculated to be: $I_{Ripple} = 0.4$ A.

The ripple current is chosen such that the converter enters discontinuous mode (DCM) at 20% of maximum load. The 20% is a typical value, although it could go higher to a maximum of up to 40%.

8.2.2.3.3 Calculate the Inductor Value (L1)

Using [Equation 33](#), the inductor value is calculated to be, $L_{Min} = 12.3$ μ H. A closest standard inductor value can be used.

8.2.2.3.4 Calculate the Output Capacitor and ESR (C4, C12)

8.2.2.3.4.1 Calculate Capacitance

To calculate the capacitance of the output capacitor, minimum load current must be first determined. Typically, in standby mode the load current is 100 μ A; however, this really depends on the application. With this value of minimum load current and using [Equation 27](#), [Equation 28](#), and [Equation 29](#), C4 is calculated to be, $C4 > 56$ μ F .

To allow wider operating conditions and improved performance in low-power mode, TI recommends using a 100- μ F capacitor. An output capacitor with a higher value allows improved transient response during load stepping.

8.2.2.3.4.2 Calculate ESR

Using [Equation 30](#), ESR is calculated to be, $R_{ESR} < 330$ m Ω .

Capacitors with lowest ESR values should be selected. To meet both the requirements, capacitance and low ESR, several low ESR capacitors may be connected in parallel. In this example, we will select a capacitor with ESR value as 30 m Ω .

Filter capacitor (C12) of value 0.1 μ F can be added to filter out the noise in the output line.

8.2.2.3.5 Calculate the Feedback Resistors (R4, R5)

To keep the quiescent current low and avoid instability problems, TI recommends selecting R4 and R5 such that, $R4 + R5$ is approximately 250 k Ω .

Using [Equation 1](#) and using a fixed standard value of $R4 = 187$ k Ω , R5 is calculated to be, $R5 = 59.8$ k Ω .

8.2.2.3.6 Calculate Type 3 Compensation Components

8.2.2.3.6.1 Resistances (R6, R9)

Using [Equation 16](#), for $V_{IN_{Typ}} = 14$ V, V_{Ramp} is calculated to be, $V_{Ramp} = 1.4$ V.

Using [Equation 12](#), f_{LC} is calculated to be, $f_{LC} = 4.54$ kHz.

Using V_{Ramp} , f_{LC} from above, assuming f_c as 1/10th of f_{sw} and [Equation 38](#), R6 is calculated to be, $R6 = 244$ k Ω .

Using [Equation 39](#), R9 is calculated to be, $R9 = 2.9$ k Ω .

8.2.2.3.6.2 Capacitors (C5, C8, C7)

Using [Equation 40](#), C5 is calculated to be, $C5 = 287.04$ pF.

Using [Equation 13](#), f_{ESR} is calculated to be, $f_{ESR} = 53.06$ kHz.

Using [Equation 42](#), C8 is calculated to be, $C8 = 12.84 \text{ pF}$.

Using [Equation 41](#), C7 is calculated to be, $C7 = 184.4 \text{ pF}$.

8.2.2.3.7 Calculate Soft-Start Capacitor (C6)

The recommended value of soft-start capacitor is 100 nF (typical).

8.2.2.3.8 Calculate Bootstrap Capacitor (C3)

The recommended value of bootstrap capacitor is 0.1 μF (typical).

8.2.2.3.9 Calculate Power-On Reset Delay Capacitor (C2)

To achieve 2.2-ms delay, the reset delay capacitor can be calculated using [Equation 6](#) to be $C2 = 2.2 \text{ nF}$.

8.2.2.3.10 Calculate Input Capacitor (C1, C11)

Typical values for C11 are 0.1 μF and 0.01 μF .

Input capacitor (C1) should be rated more than the maximum input voltage ($V_{IN_{Max}}$). The input capacitor should be big enough to maintain supply in case of transients in the input line. Using [Equation 26](#), C1 is calculated to be, $C1 = 10.53 \text{ }\mu\text{F}$. For improved transient response, TI recommends a higher value of C1 such as 220 μF .

8.2.2.3.11 Calculate Resistors to Control Slew Rate (R7)

The value of slew rate resistor (R7) can be approximately determined from [Figure 11](#) and [Figure 12](#) at different typical input voltages. The minimum recommended value is 10 k Ω . To achieve rise time, $t_r = 20 \text{ ns}$ and fall time, $t_f = 35 \text{ ns}$, the slew rate resistor is approximately of value 30 k Ω .

8.2.2.3.12 Resistors to Select Undervoltage, Overvoltage and Reset Threshold Values (R1, R2, R3)

The sum of these three resistors should be approximately equal to 100 k Ω . In this example,

$$V_{Reg_OV} = 106\% \text{ of } V_{Reg} = 3.498 \text{ V}$$

$$V_{Reg_RST} = 92\% \text{ of } V_{Reg} = 3.036 \text{ V}$$

$$V_{Reg_UV} = 95\% \text{ of } V_{Reg} = 3.135 \text{ V}$$

Using [Equation 9](#), $R3 = 22.87 \text{ k}\Omega$.

Using [Equation 8](#), $R2 = 3.48 \text{ k}\Omega$.

Using [Equation 7](#), $R1 = 73.65 \text{ k}\Omega$

8.2.2.3.13 Diode D1 and D2 Selection

Diode D1 is used to protect the IC from the reverse input polarity connection. The diode should be rated at maximum load current. Only Schottky diode should be connected at the PH pin. The recommended part numbers are PDS360 and SBR8U60P5.

8.2.2.3.14 Noise Filter on RST_TH and OV_TH Terminals (C9 and C10)

Typical capacitor values for RST_TH and OV_TH pins are from 10 pF to 100 pF for total resistance on RST_TH/OV_TH divider of less than 200 k Ω .

8.2.2.3.15 Power Budget and Temperature Estimation

Using [Equation 43](#), conduction losses for typical input voltage are calculated to be, $P_{CON} = 0.235 \text{ W}$.

Assuming slew resistance $R7 = 30 \text{ k}\Omega$, from [Figure 17](#) and [Figure 18](#), rise time, $t_r = 20 \text{ ns}$ and fall time, $t_f = 35 \text{ ns}$. Using [Equation 19](#), switching losses for typical input voltage are calculated to be, $P_{SW} = 0.913 \text{ W}$.

Using [Equation 44](#), gate drive losses are calculated to be, $P_{Gate} = 3.5 \text{ mW}$.

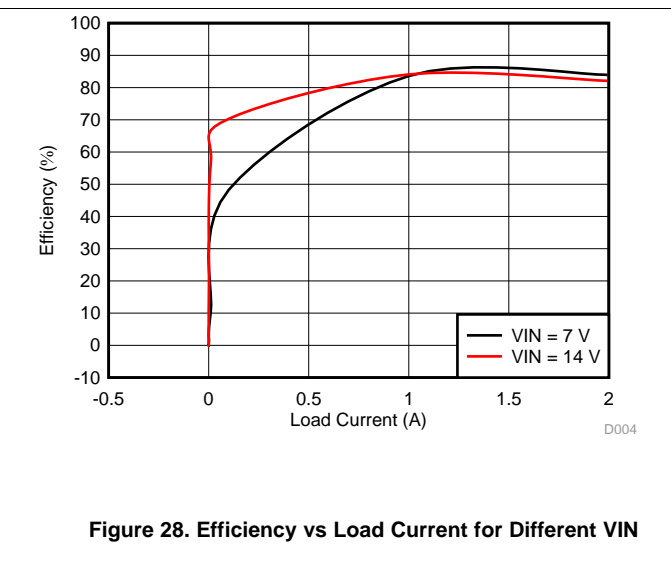
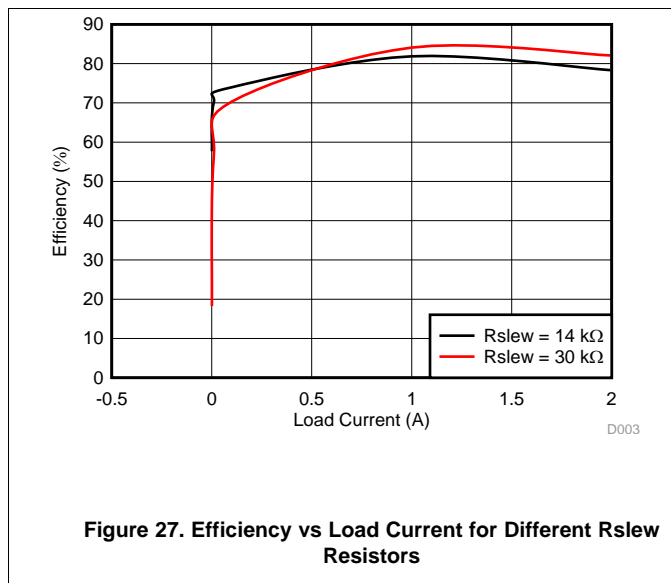
Using [Equation 46](#), power supply losses are calculated to be, $P_{IC} = 1.8 \text{ mW}$.

Using Equation 47, the total power dissipated by the device is calculated to be, $P_{Total} = 1.15 \text{ W}$.

Using Equation 49, and knowing the thermal resistance of package = 35°C/W , the rise in junction temperature due to power dissipation is calculated to be, $\Delta T = 40.4^{\circ}\text{C}$.

Using Equation 50, for a given maximum junction temperature 150°C , the maximum ambient temperature at which the device can be operated is calculated to be, T_{A-Max} approximately 105°C .

8.2.3 Application Curves



9 Power Supply Recommendations

The design of the TPS54262-EP devices is for operation using an input supply range from 3.6 V to 48 V. Both the VIN input pins must be shorted together at the board level. One high frequency filter capacitor in the range from 0.1 μ F to 0.01 μ F is recommended at VIN pin. Additionally, to minimize the ripple voltage, use a ceramic bulk capacitor of type X5R or X7R at the VIN pin. See [Equation 25](#) and [Equation 26](#) for calculating the value of this bulk capacitor. If there is a possibility for a reverse-voltage condition to occur, place a series Schottky diode in the power routing.

10 Layout

10.1 Layout Guidelines

A proper layout is critical for the operation of a switched-mode power supply, even more at high switching frequencies. Therefore, the PCB layout of the TPS54262-EP device demands careful attention to ensure operation and to get the performance specified. A poor layout can lead to issues like poor regulation (line and load), stability and accuracy weaknesses, increased EMI radiation, and noise sensitivity. See [Figure 29](#) for recommended layout example for TPS54262-EP device.

- It is critical to provide a low-inductance, low-impedance ground path and hence use wide and short traces for the main current paths.
- The input capacitor, catch diode, output capacitor, and inductor should be placed as close as possible to the IC pins and use thick traces (low impedance path) to connect them.
- Route the feedback trace so that there is minimum interaction with any noise sources associated with the switching components. Recommended practice is to place the inductor away from the feedback trace to prevent EMI noise.
- Place compensation network components away from switching components and route their connections away from noisy area.
- In a two-sided PCB, TI recommends having ground planes on both sides of the PCB to help reduce noise and ground-loop errors. Connect the ground connection for the input and output capacitors and IC ground to this ground plane.
- In a multilayer PCB, the ground plane separates the power plane (where high switching currents and components are placed) from the signal plane (where the feedback trace and components are) for improved performance.
- Also, arrange the components such that the switching-current loops curl in the same direction. Place the high-current components such that during conduction the current path is in the same direction. Doing so prevents magnetic field reversal caused by the traces between the two half cycles, helping to reduce radiated EMI.
- Add multiple thermal via's on the device thermal pad for better thermal performance.

10.2 Layout Example

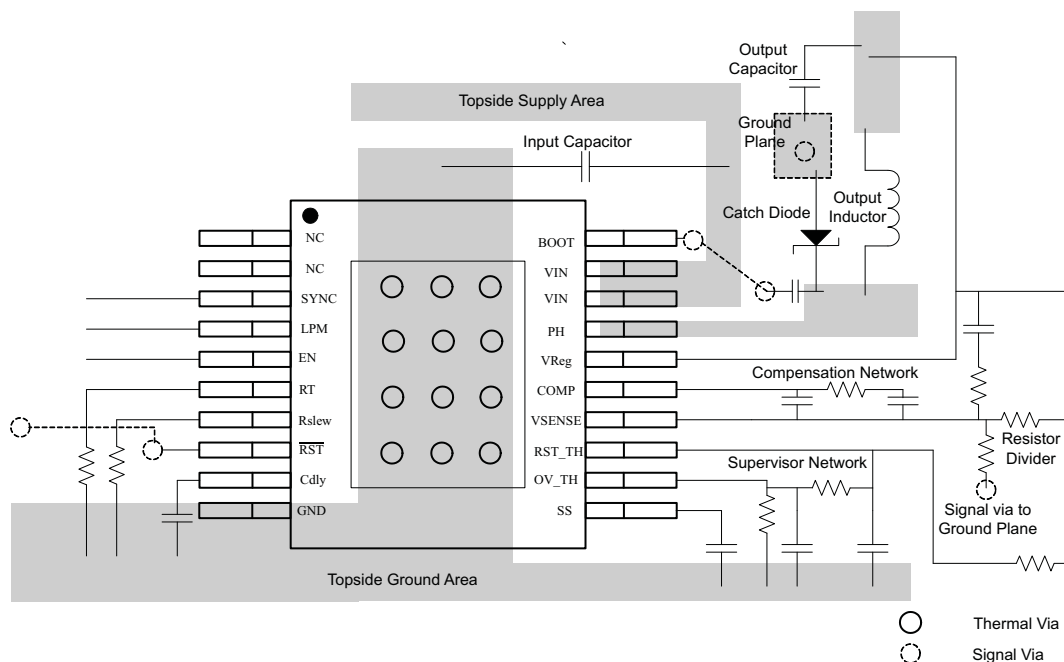


Figure 29. PCB Layout Example

10.3 Power Dissipation and Temperature Considerations

The power dissipation losses are applicable for continuous conduction mode operation (CCM). The total power dissipated by the device is the sum of the following power losses.

Conduction losses, P_{CON}

$$P_{CON} = I_{Load}^2 \times R_{DS(ON)} \times \frac{V_{Reg}}{VIN} \quad (43)$$

Switching losses, P_{SW}

$$P_{SW} = \frac{1}{2} VIN \times I_{Load} \times (t_r + t_f) \times f_{SW} \quad (44)$$

Gate drive losses, P_{Gate}

$$P_{Gate} = V_{drive} \times Q_g \times f_{sw} \quad (45)$$

Power supply losses, P_{IC}

$$P_{IC} = VIN \times I_{q-Normal} \quad (46)$$

Therefore, the total power dissipated by the device is given by [Equation 47](#).

$$P_{Total} = P_{CON} + P_{SW} + P_{Gate} + P_{IC}$$

where

- VIN = unregulated input voltage
- I_{Load} = output load current
- t_r = FET switching rise time ($t_r = 40$ ns (maximum))
- t_f = FET switching fall time
- f_{sw} = switching frequency
- V_{drive} = FET gate drive voltage ($V_{drive} = 6$ V (typical), $V_{drive} = 8$ V (maximum))
- $Q_g = 1 \times 10^{-9}$ C
- $I_{q-Normal}$ = quiescent current in normal mode (Active Mode CCM) (47)

For device under operation at a given ambient temperature (T_A), the junction temperature (T_J) can be calculated using [Equation 48](#).

$$T_J = T_A + (R_{th} \times P_{Total}) \quad (48)$$

Therefore, the rise in junction temperature due to power dissipation is shown in [Equation 49](#).

$$\Delta T = T_J - T_A = (R_{th} \times P_{Total}) \quad (49)$$

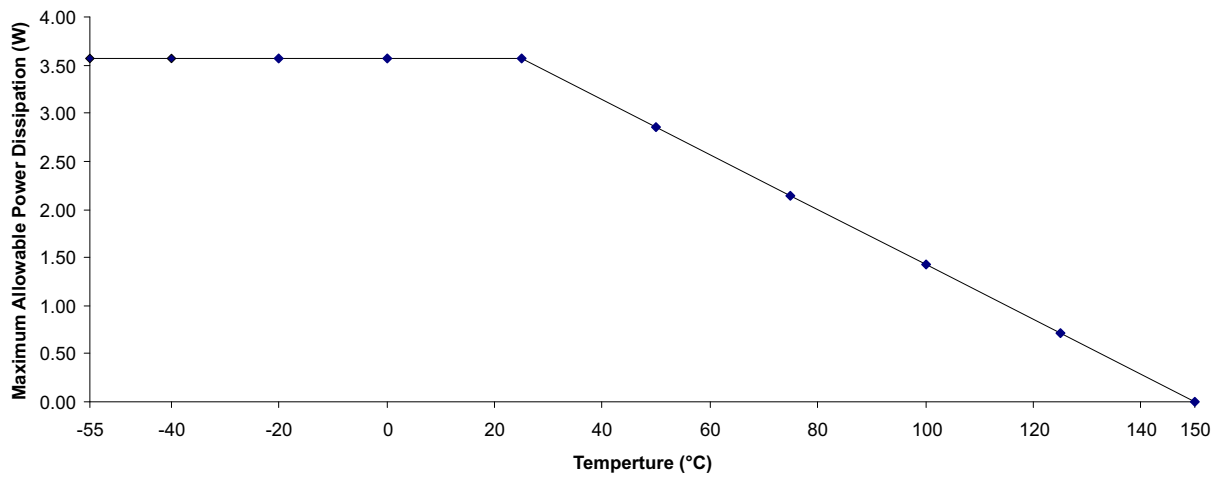
For a given maximum junction temperature (T_{J-Max}), the maximum ambient temperature (T_{A-Max}) in which the device can operate is calculated using [Equation 50](#).

$$T_{A-Max} = T_{J-Max} - (R_{th} \times P_{Total})$$

where

- T_J = junction temperature in °C
- T_A = ambient temperature in °C
- R_{th} = thermal resistance of package in W/°C
- T_{J-Max} = maximum junction temperature in °C
- T_{A-Max} = maximum ambient temperature in °C (50)

There are several other factors that also affect the overall efficiency and power losses. Examples of such factors are AC and DC losses in the inductor, voltage drop across the copper traces on PCB, power losses in the flyback catch diode and so forth. The previous discussion does not include such factors.

Power Dissipation and Temperature Considerations (continued)

Figure 30. Power Dissipation vs Ambient Temperature
NOTE

The output current rating for the regulator may must be derated for ambient temperatures above 85°C. The derated value will depend on calculated worst-case power dissipation and the thermal management implementation in the application.

11 器件和文档支持

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11.5 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12 机械、封装和可订购信息

以下页中包括机械、封装和可订购信息。这些信息是针对指定器件可提供的最新数据。这些数据会在无通知且不对本文档进行修订的情况下发生改变。欲获得该数据表的浏览器版本，请查阅左侧的导航栏。

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPS54262MPWPREP	ACTIVE	HTSSOP	PWP	20	2000	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-55 to 125	54262M1	Samples
TPS54262MPWPTEP	ACTIVE	HTSSOP	PWP	20	250	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-55 to 125	54262M1	Samples
V62/16626-01XE	ACTIVE	HTSSOP	PWP	20	250	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-55 to 125	54262M1	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

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(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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THERMAL PAD MECHANICAL DATA

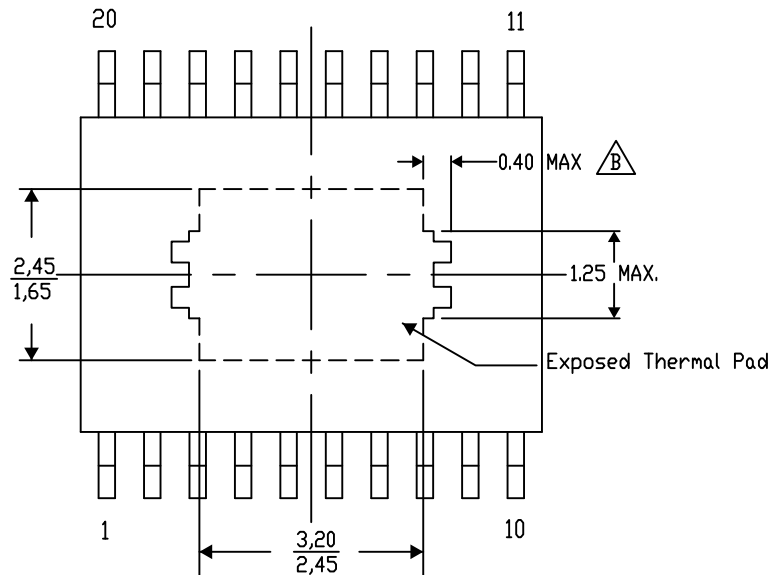
PWP (R-PDSO-G20) PowerPAD™ SMALL PLASTIC OUTLINE

THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached to a printed circuit board (PCB). The thermal pad must be soldered directly to the PCB. After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).


For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



4206332-18/AO 01/16

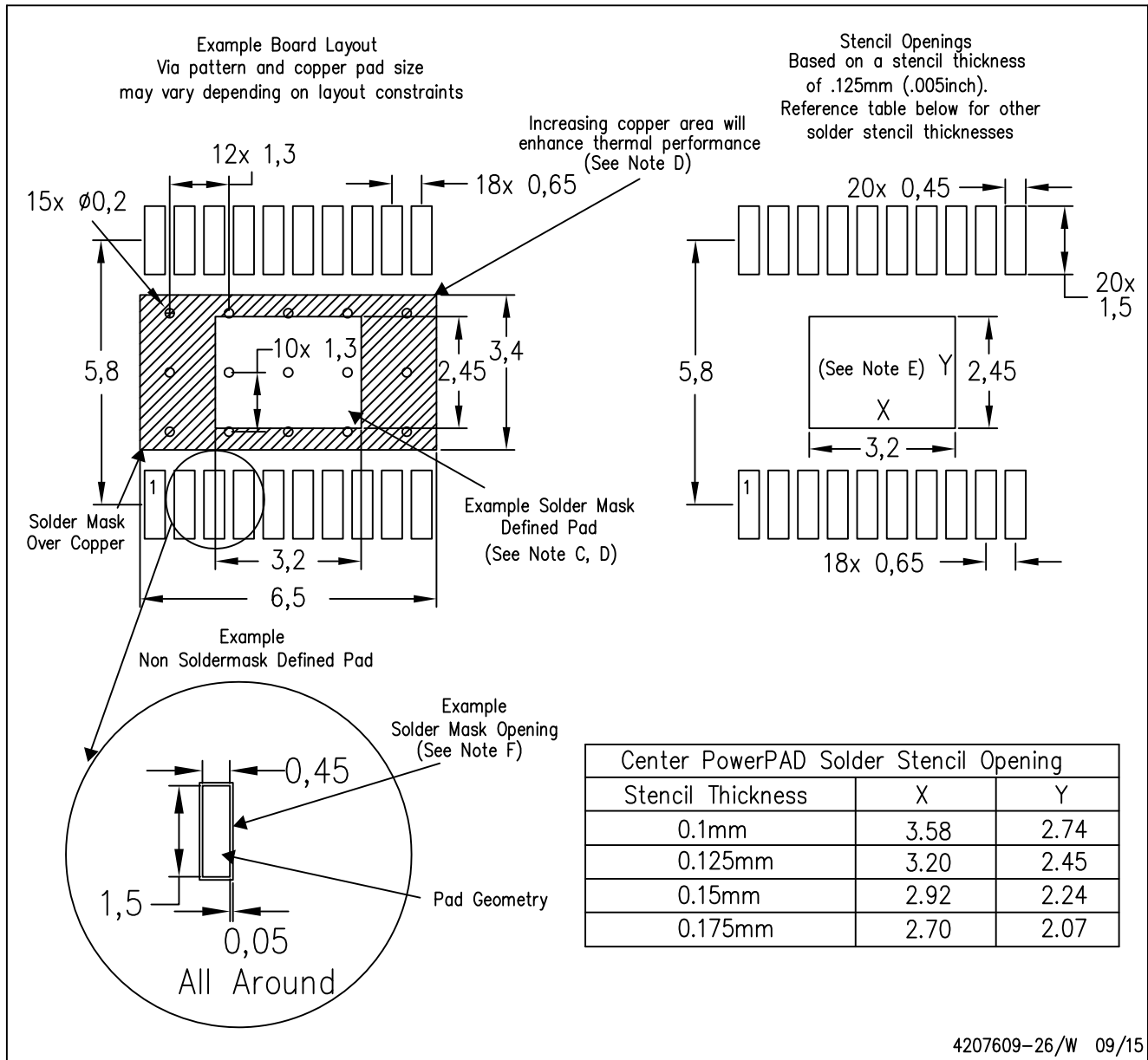
NOTE: A. All linear dimensions are in millimeters

 Exposed tie strap features may not be present.

PowerPAD is a trademark of Texas Instruments

PWP (R-PDSO-G20)

PowerPAD™ PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
 - This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>. Publication IPC-7351 is recommended for alternate designs.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
 - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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